



Joint ICTP-IAEA Advanced Workshop on Single Ion Technologies for Bio-medical and Materials Sciences

30 June – 4 July 2025

Single Ion Detection II: where

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www.solid.unito.it

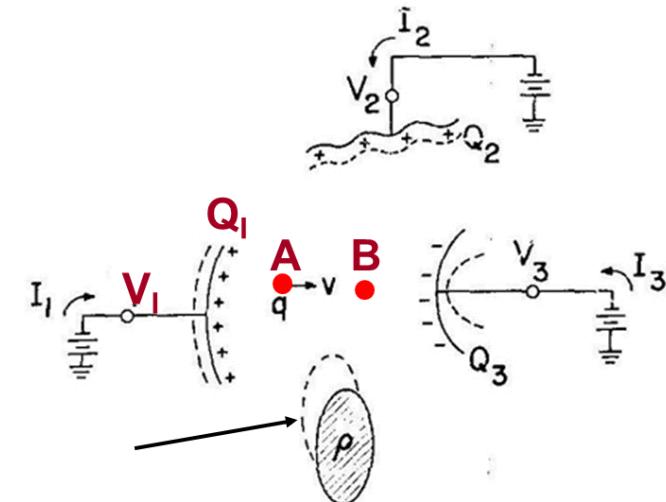
Summary

- Induced charge in multielectrode semiconductor devices
- A “simple” linear position sensitive detector
- Examples of a two dimensional position sensitive detectors
- Sensitivity, spectral and spatial resolution

Gunn's Theorem

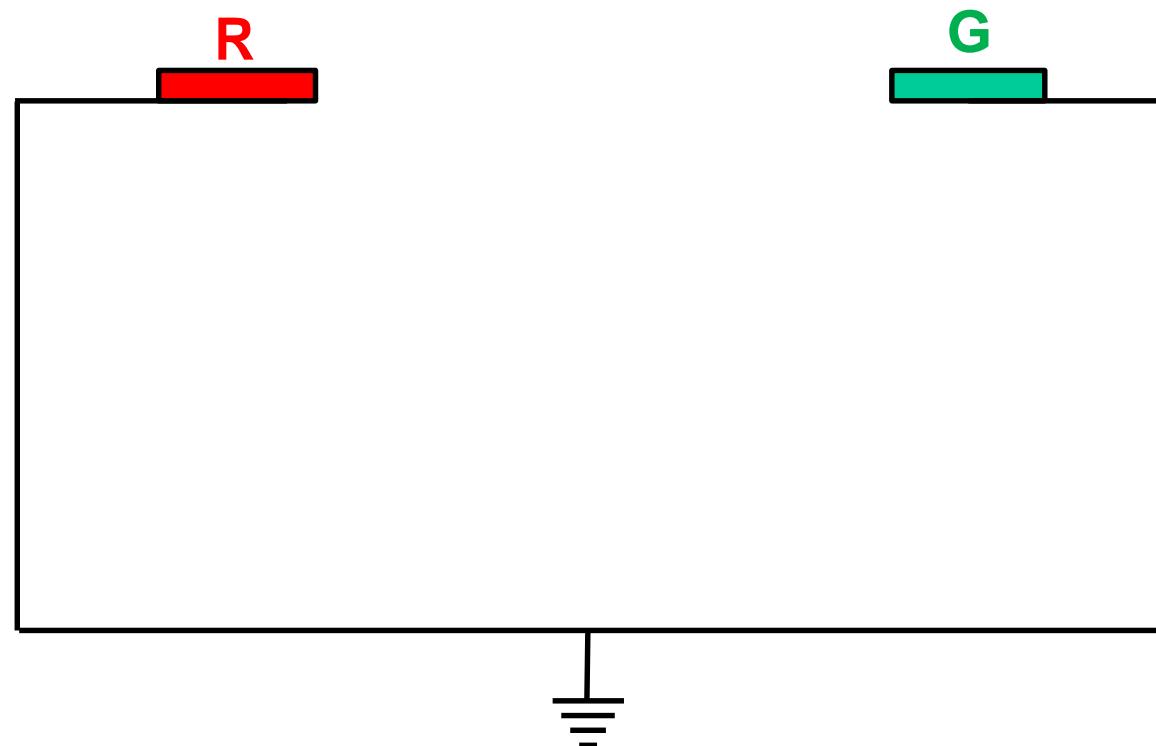
$$\nabla_r Q_i = -q \cdot \frac{\partial \mathbf{E}}{\partial V_i} = -q \cdot \mathbf{E}_w$$

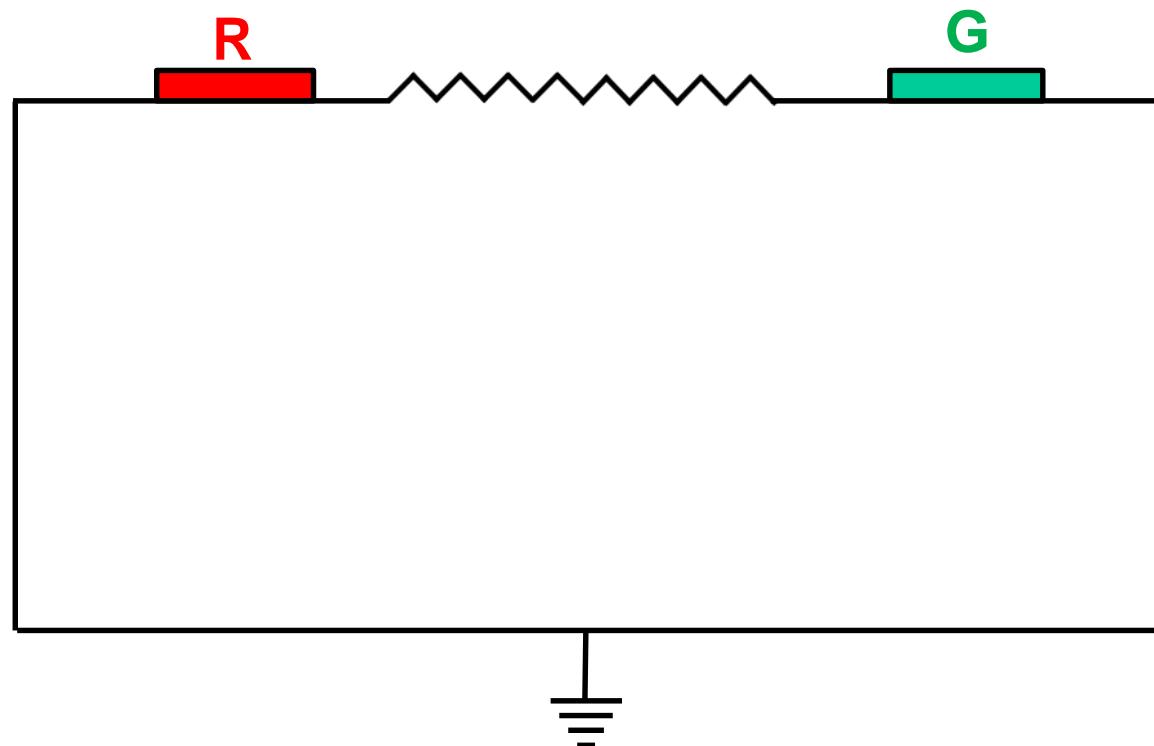
$$Q = q \cdot [\Psi_w(B) - \Psi_w(A)]$$



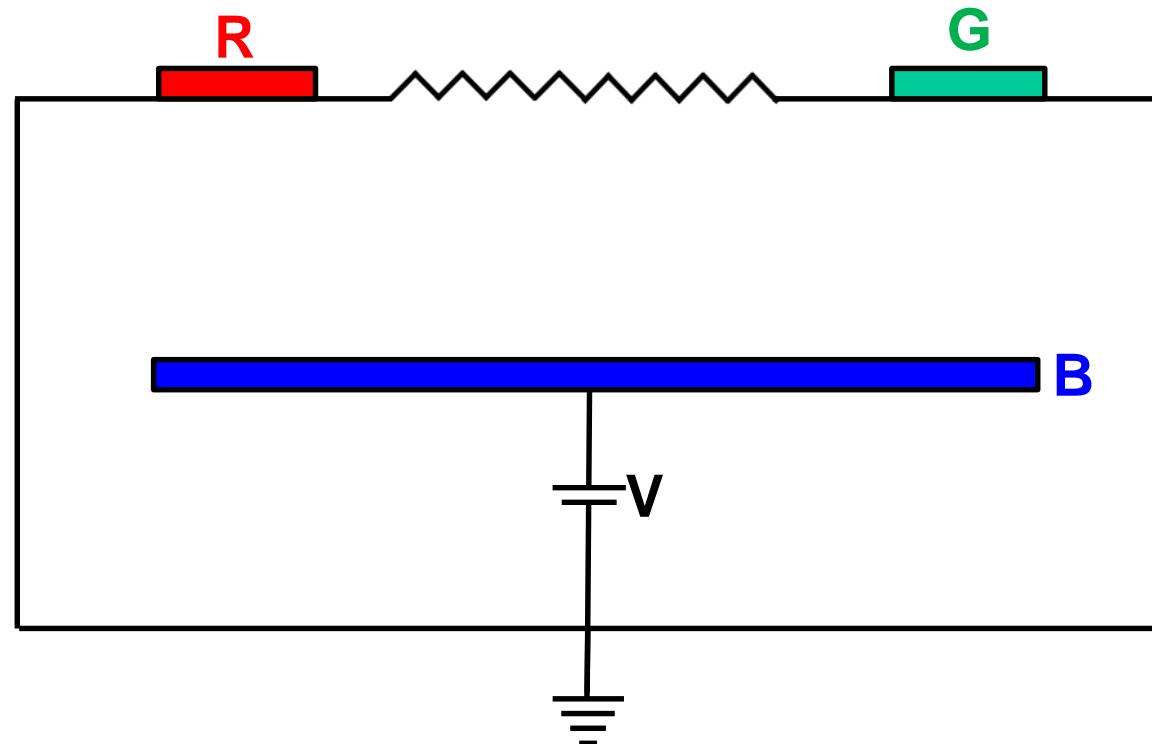
The induced charge Q at the sensing electrode is given by the difference in the weighting potentials between any two positions (A and B) of the moving charge

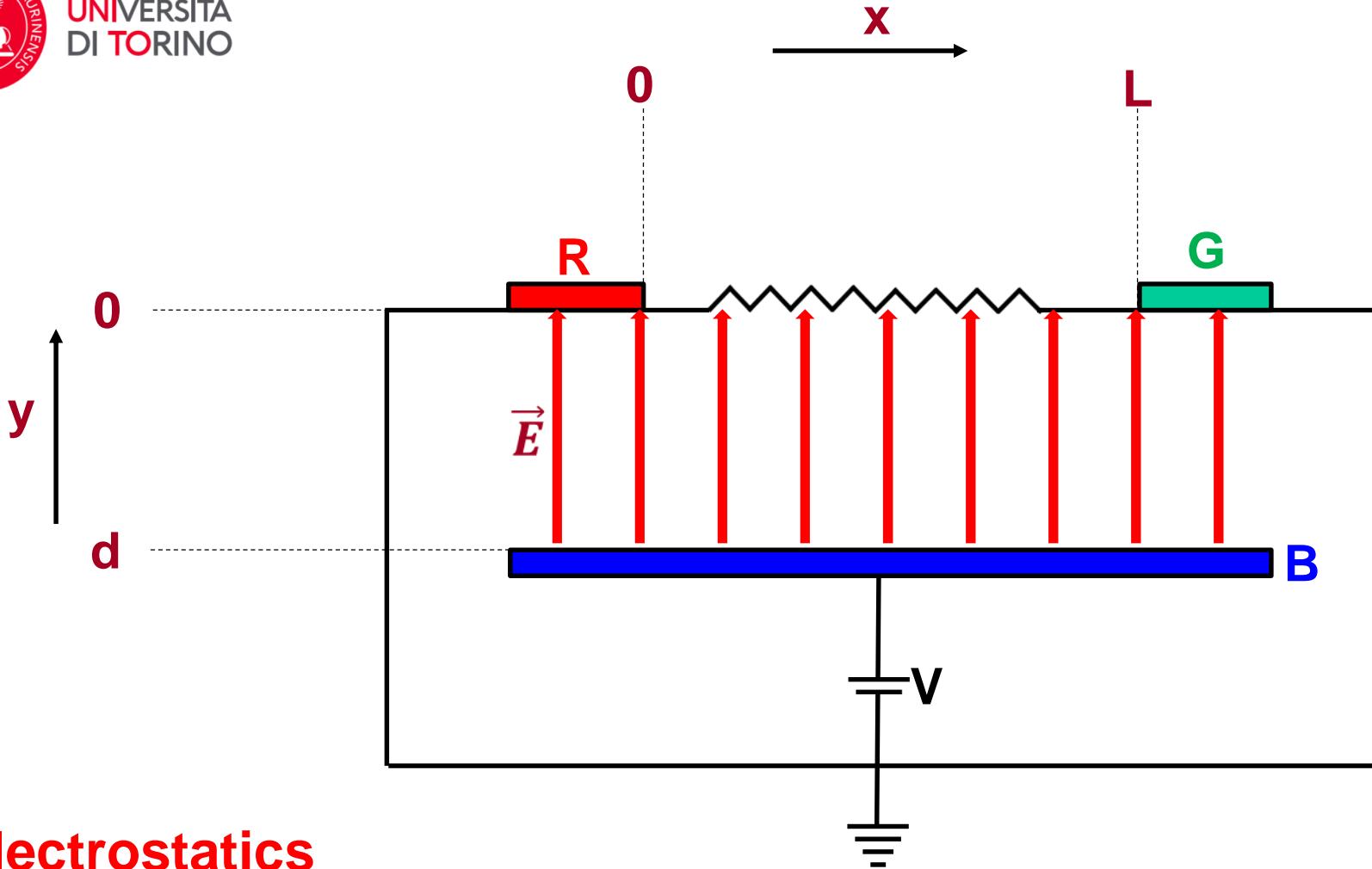
CHARGE SHARING IN MULTIELECTRODE DEVICES





Three electrodes R, G, B



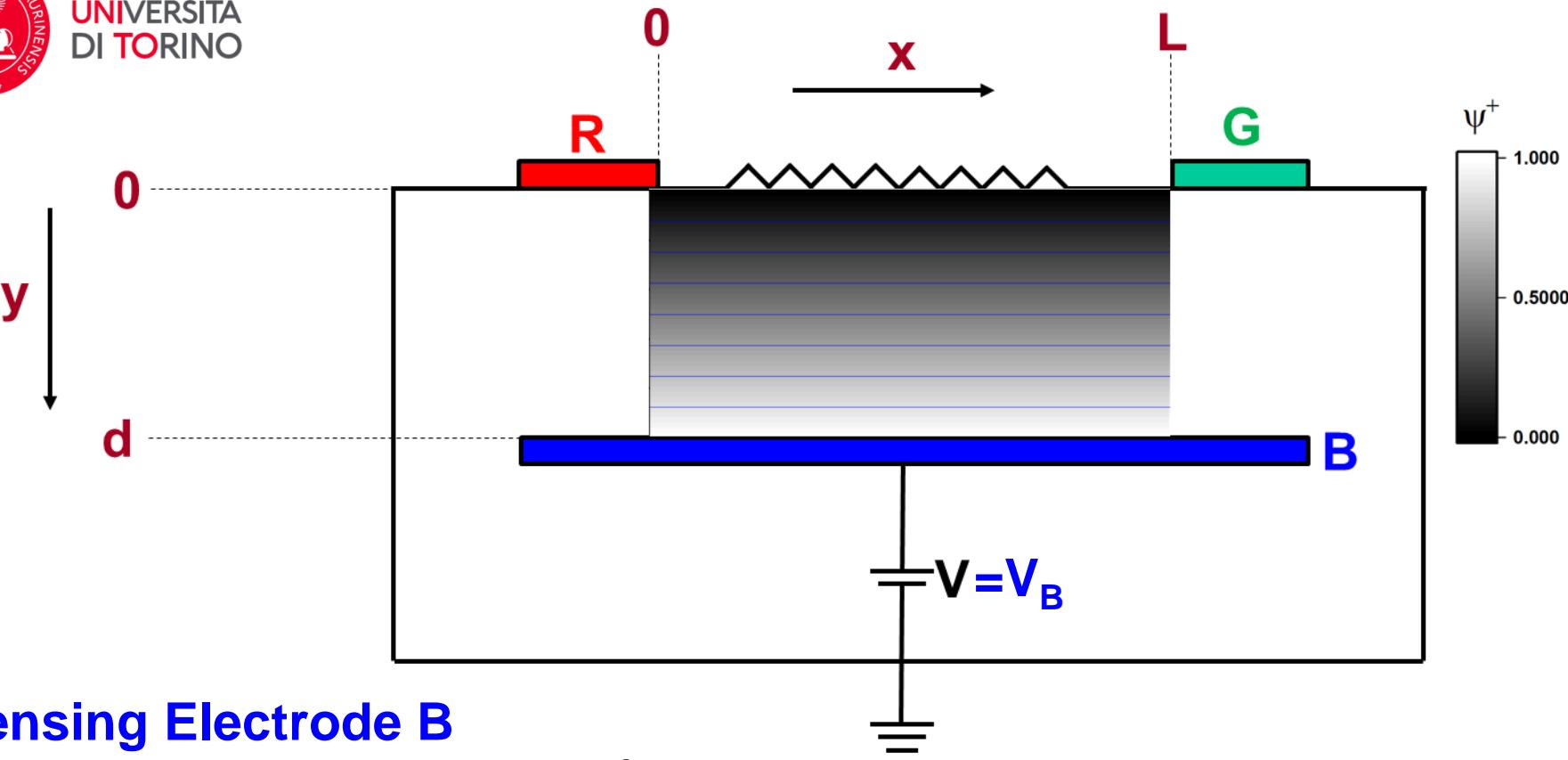


Electrostatics

Electric potential: $\psi = V \cdot \frac{x}{d}$

Electric Field: $E = -\frac{V}{d}$

Vertical trajectories



Sensing Electrode B

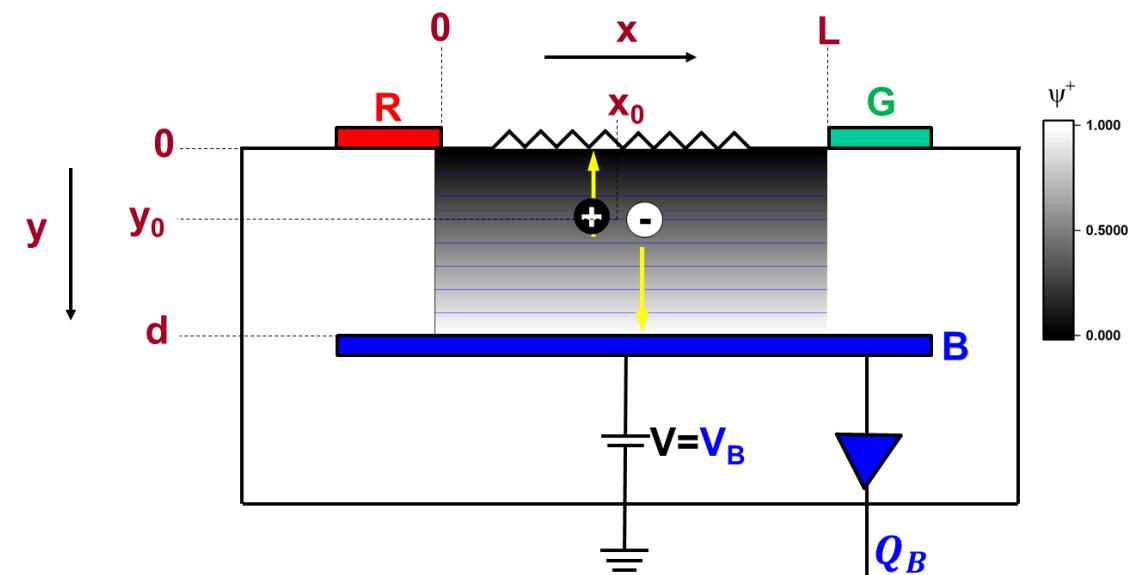
Weighting Potential $\psi_{wB} = \frac{\partial \psi}{\partial V} = \frac{y}{d}$

Weighting Field $E_{wB} = \frac{\partial E}{\partial V} = -\frac{1}{d}$

R and **G** are grounded

Sensing Electrode B

The induced charge Q_B at the sensing electrode B is given by the difference in the weighting potential Ψ_{wB} between any two positions of the moving charges



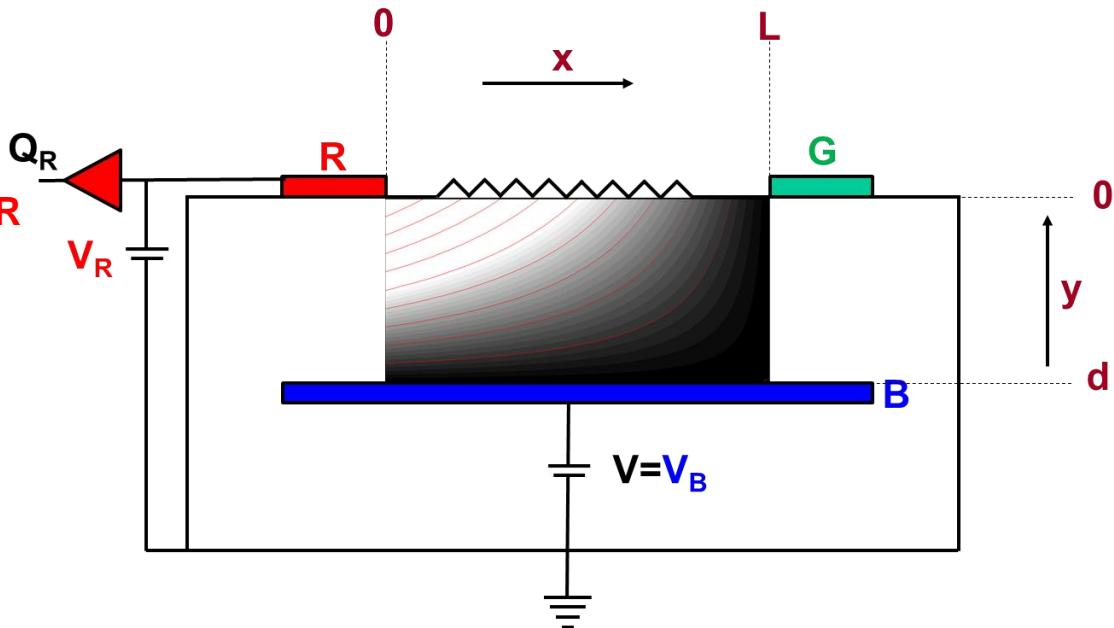
$$Q_B = -q[\psi_{wB}(y = d) - \psi_{wB}(y = y_0)] + q[\psi_{wB}(y = 0) - \psi_{wB}(y = y_0)] = q$$

electron	hole
$y=y_0; \Psi_{wB} = \frac{y_0}{d}$	$y=y_0; \Psi_{wB} = \frac{y_0}{d}$
$y=d; \Psi_{wB} = 1$	$y=0; \Psi_{wB} = 0$

Sensing Electrode R at $V=V_R$

Electrode B at $V_B=V$

Electrode G at $V_G=0$

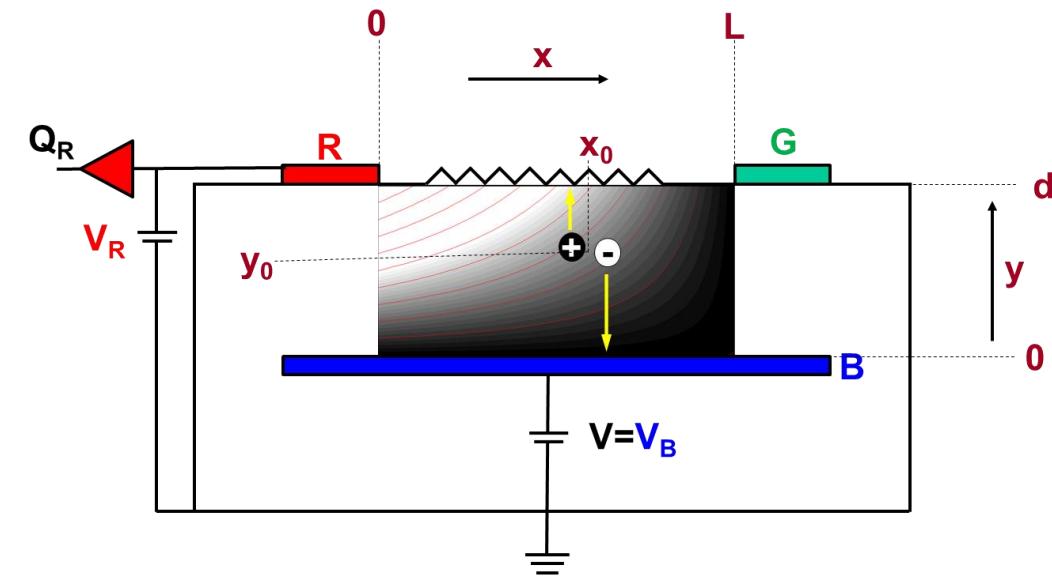


$$\text{Electric potential: } \Psi_R = V_R - \frac{V_R}{L} \cdot x + \frac{V_B - V_R}{d} \cdot y + \frac{V_R}{L \cdot d} x \cdot y$$

$$\text{Weighting Potential } \Psi_{wR} = \frac{\partial \Psi_R}{\partial V_R} = 1 - \frac{x}{L} - \frac{y}{d} + \frac{x \cdot y}{L \cdot d}$$

Sensing Electrode R

The induced charge Q_R at the sensing electrode **R** is given by the difference in the weighting potential Ψ_{wR} between any two positions of the moving charges



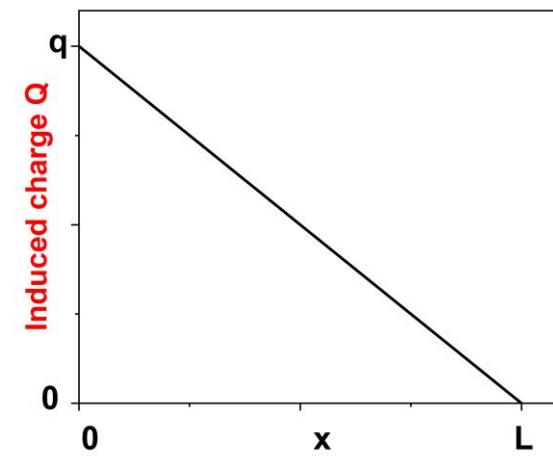
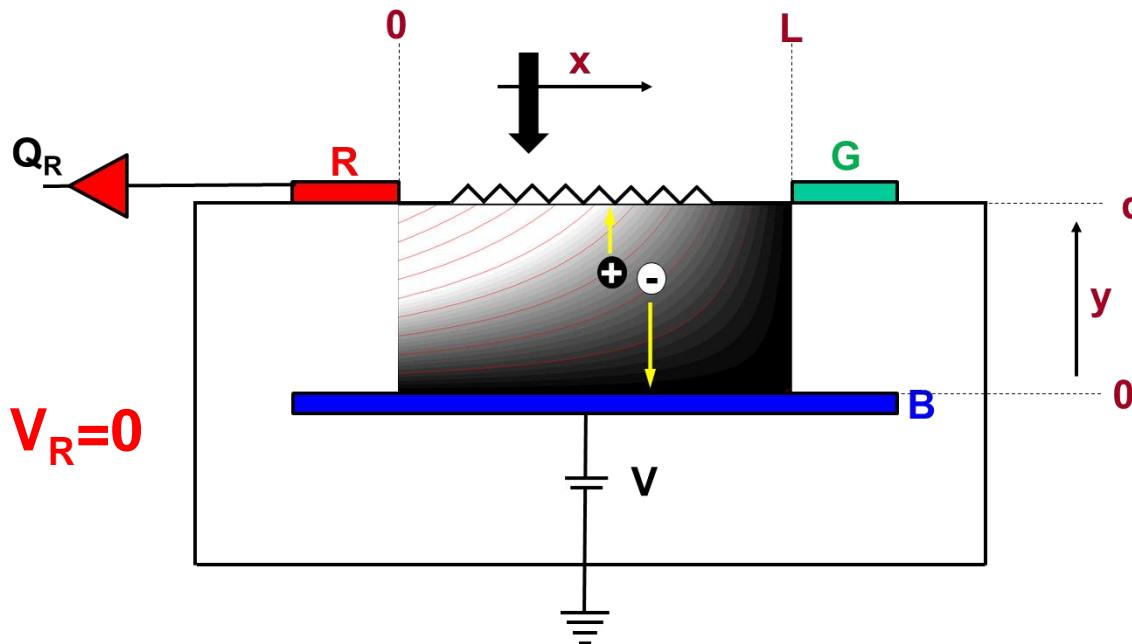
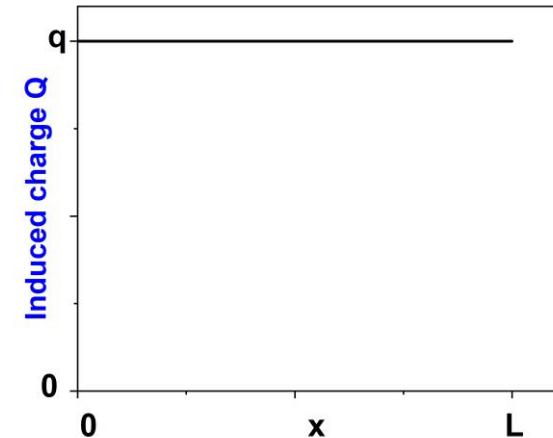
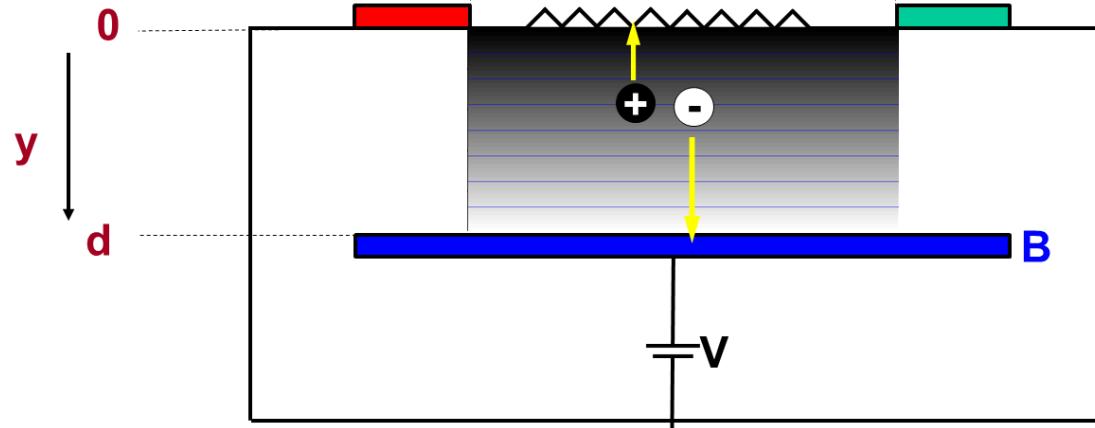
$$\text{Weighting Potential } \Psi_{wR} = \frac{\partial \Psi_R}{\partial V_R} = 1 - \frac{x}{L} - \frac{y}{d} + \frac{x \cdot y}{L \cdot d}$$

$$Q_R = -q[\Psi_{wR}(x_0, d) - \Psi_{wR}(x_0, y_0)] + q[\Psi_{wR}(x_0, 0) - \Psi_{wR}(x_0, y_0)] = 1 - \frac{x_0}{L}$$

$$\text{Initial position } \Psi_{wR}(x_0, y_0) = 1 - \frac{x_0}{L} - \frac{y_0}{d} + \frac{x_0 \cdot y_0}{L \cdot d}$$

$$\text{Electron } \Psi_{wR}(x_0, d) = 0$$

$$\text{Final position: } \begin{aligned} \text{Electron } & \Psi_{wR}(x_0, 0) = 1 - \frac{x_0}{L} \\ \text{Hole } & \Psi_{wR}(x_0, 0) = 1 - \frac{x_0}{L} \end{aligned}$$



IBIC ANALYSIS OF A LINEAR POSITION SENSITIVE DETECTOR: MODEL AND EXPERIMENT

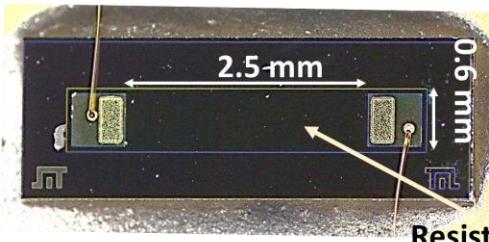
SiTeK Position Sensing Detector 1L2.5 UV

European Physical Journal 2025, 140 (5), 369

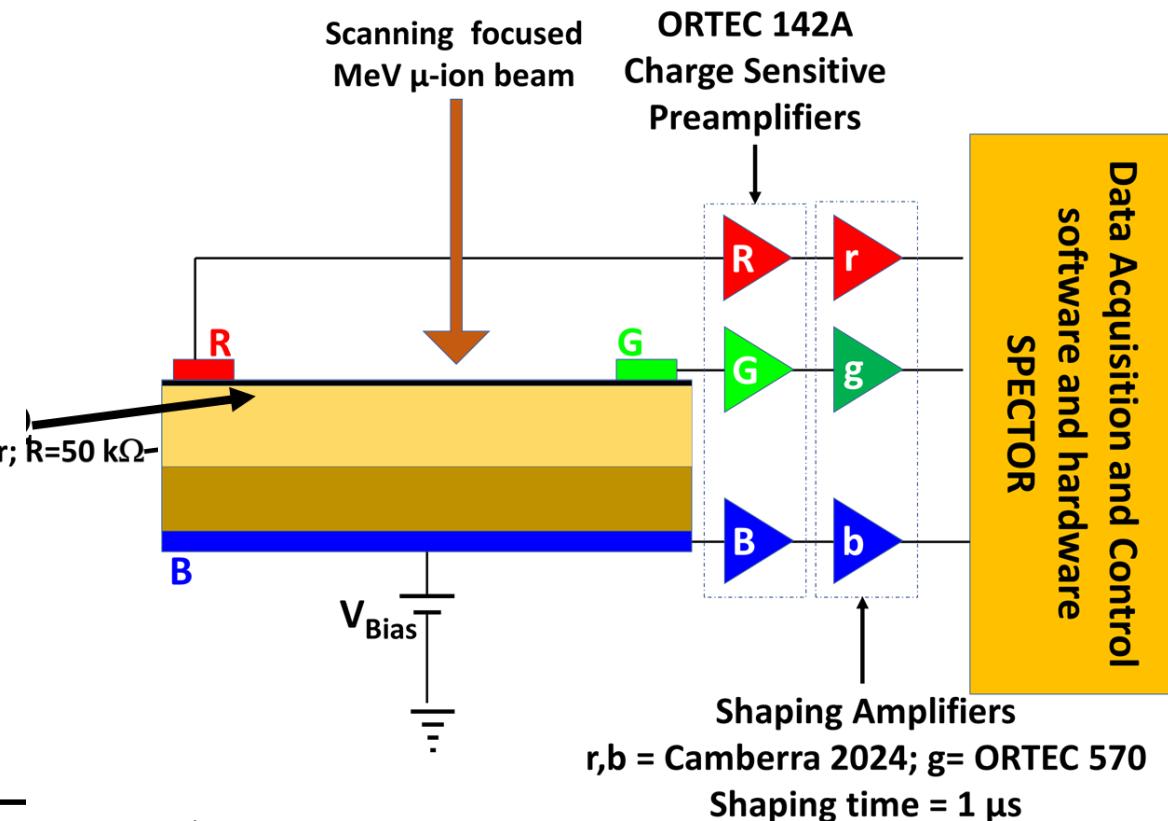


The device consists of

- A uniform resistive p-type layer formed on an n-type semiconductor substrate,
- Two electrodes (R and G) on both ends of the resistive layer
- A common electrode (B) located on the backside of the substrate.



Dark current $< 12 \text{ nA} @ 20\text{V}$



The IBIC experiment was carried out at the Laboratory for Ion Beam Interaction (LIBI) of the Ruder Boskovic Institute in Zagreb (HR).

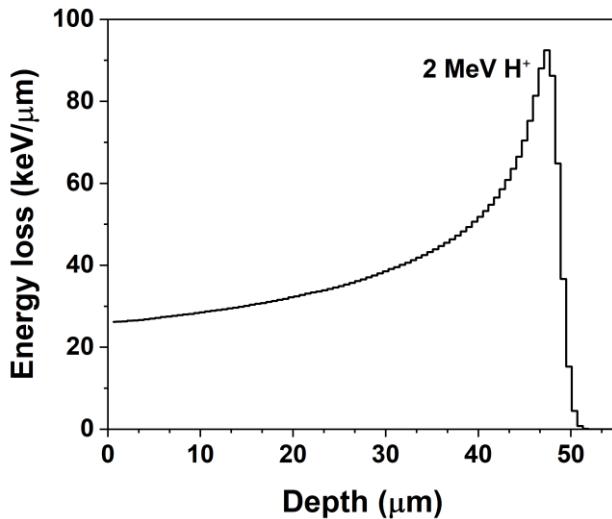
Spectral resolution: 32 keV (ORTEC PIPS detector)

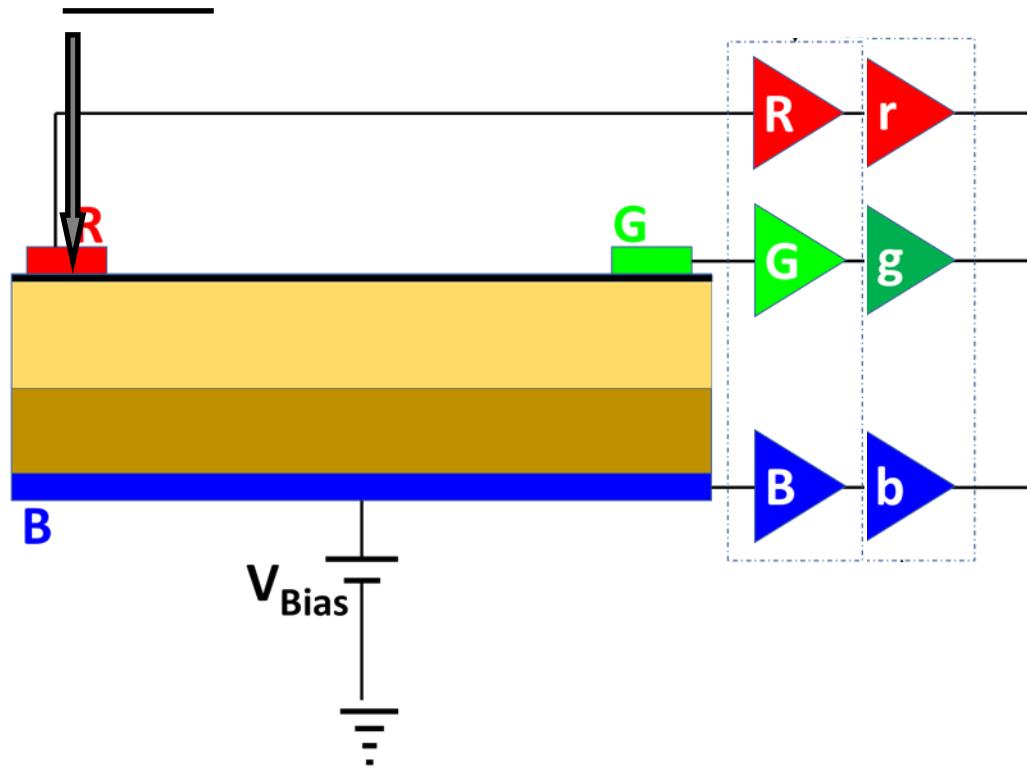
Beam spot size: 2 μm – from on-axis STIM

Pixel size: 23 μm^2

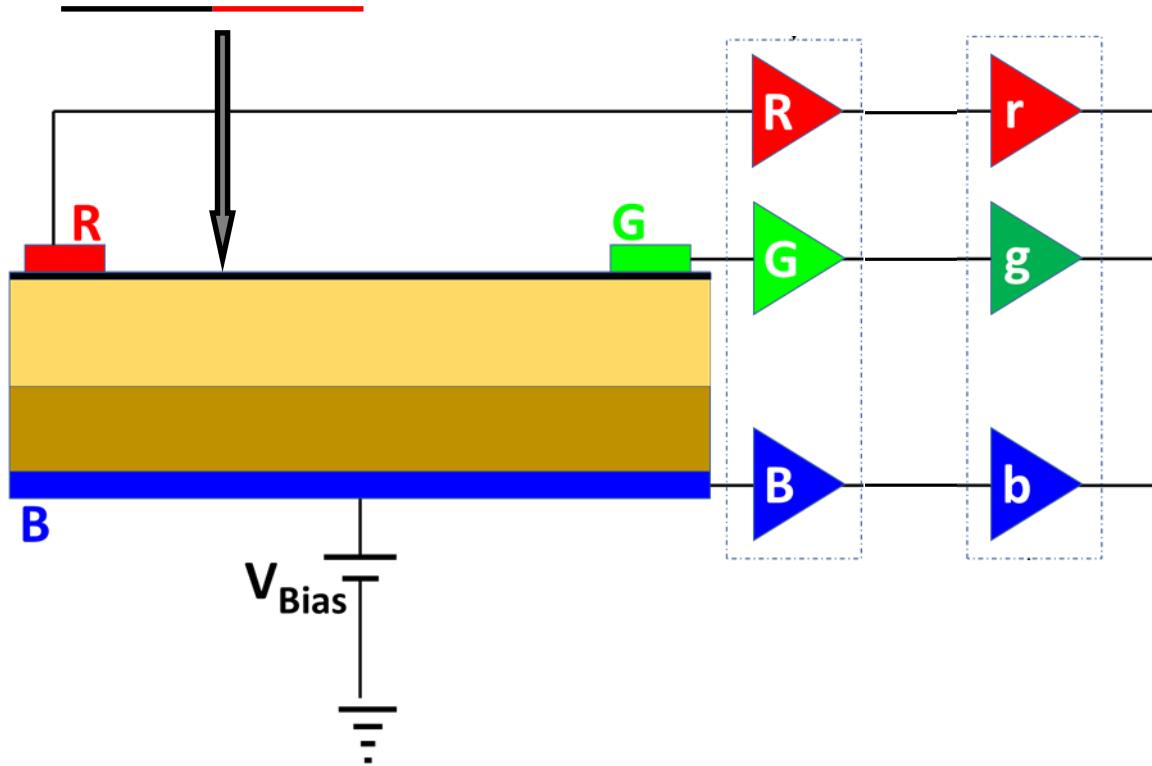
Scan area: (128x128)x(Pixel Size)=(0.62x0.62) mm²

Ion microprobe: 2 MeV protons

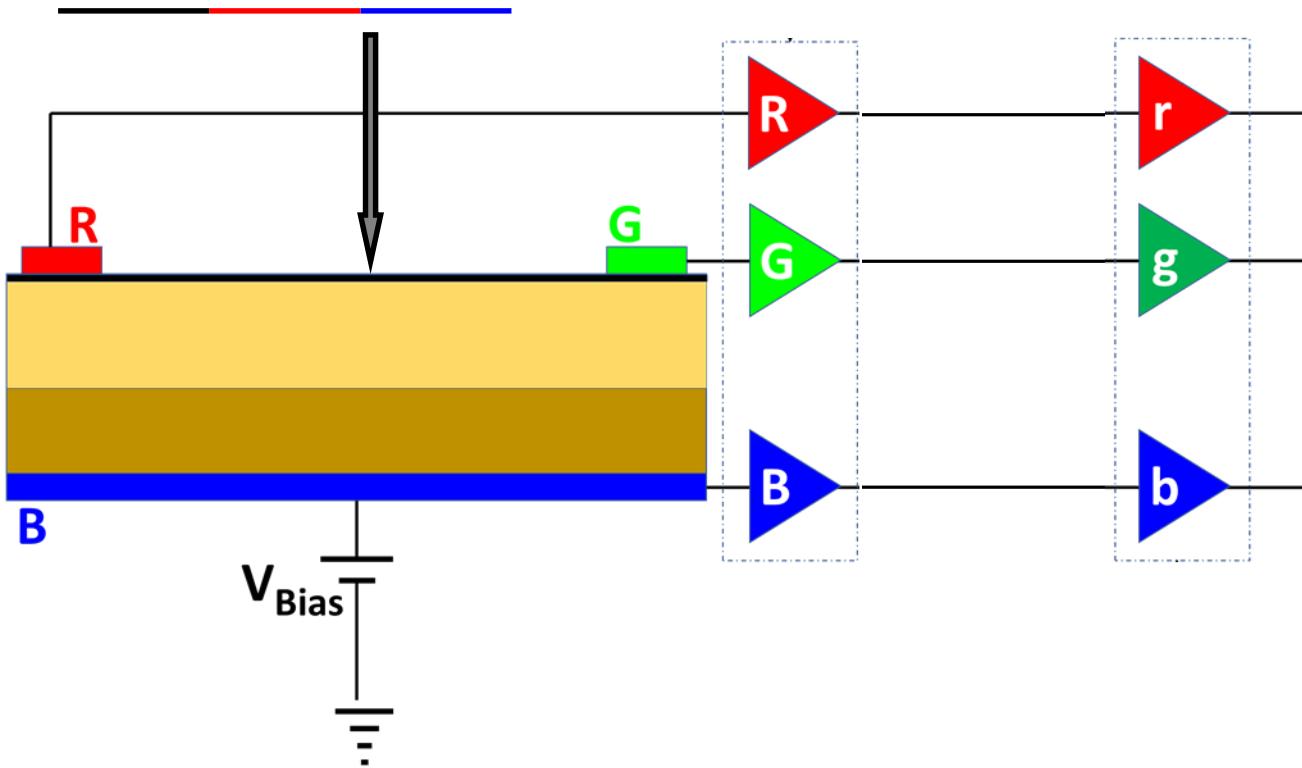




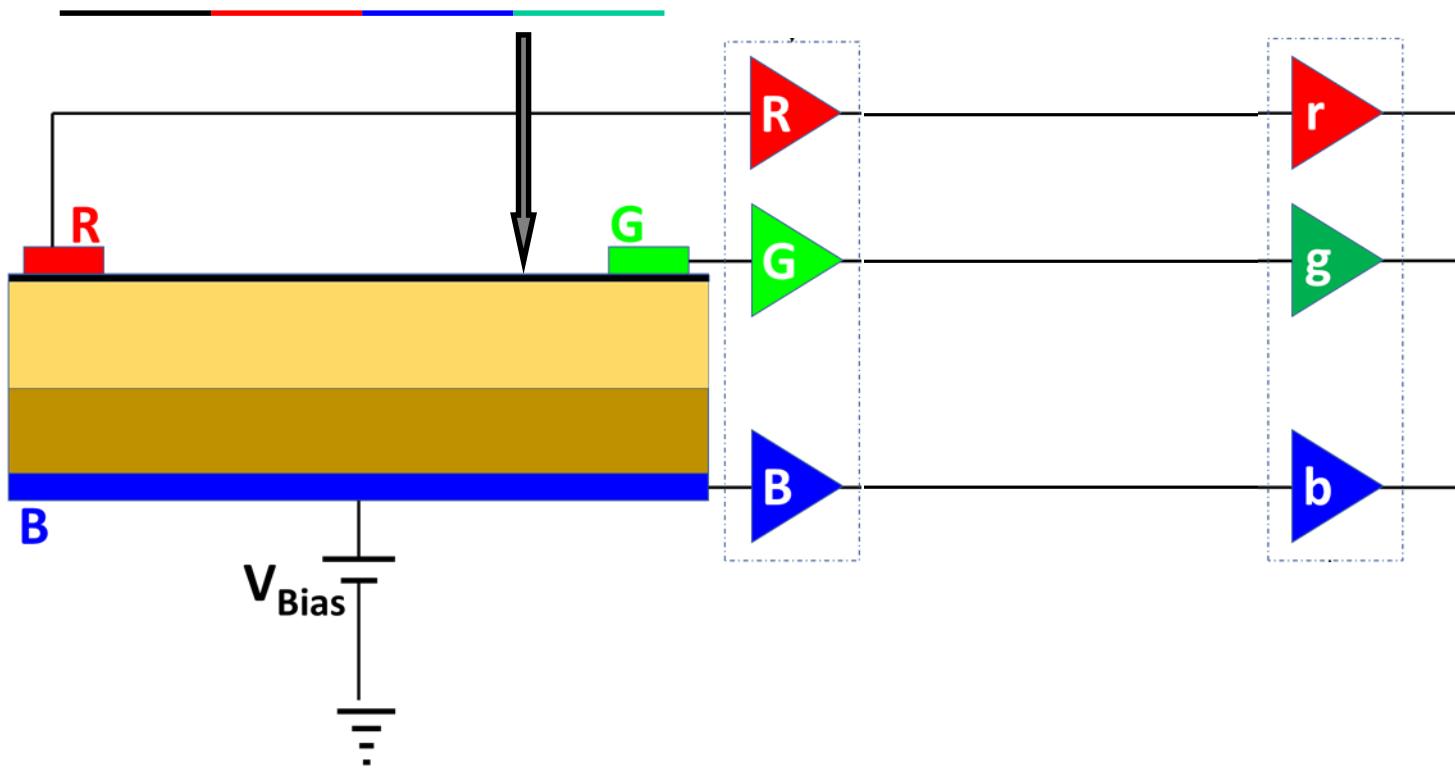
Data Acquisition and Control software and hardware SPECTOR



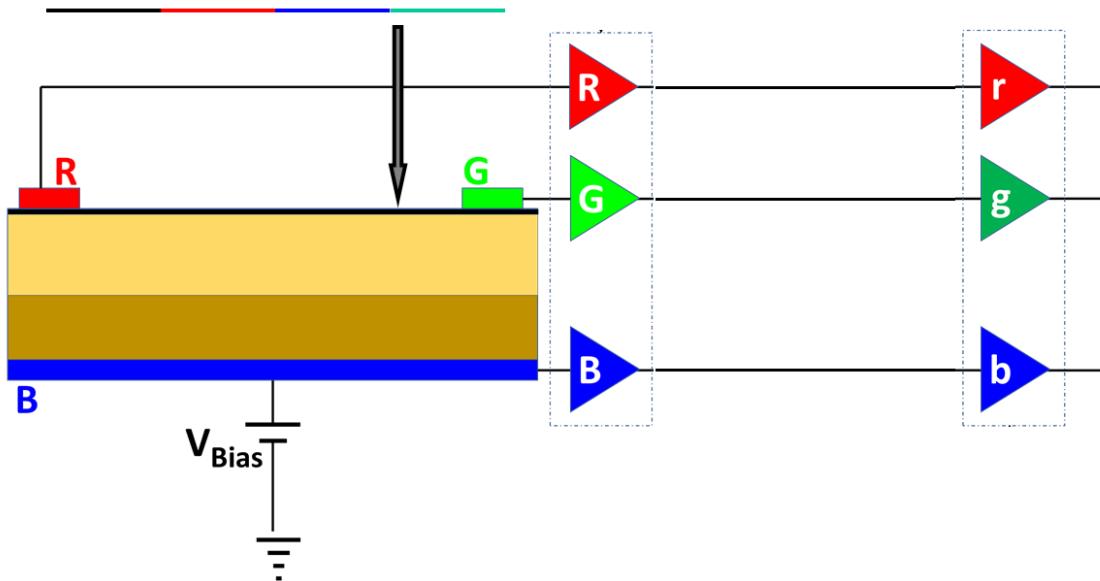
Data Acquisition and Control software and hardware SPECTOR



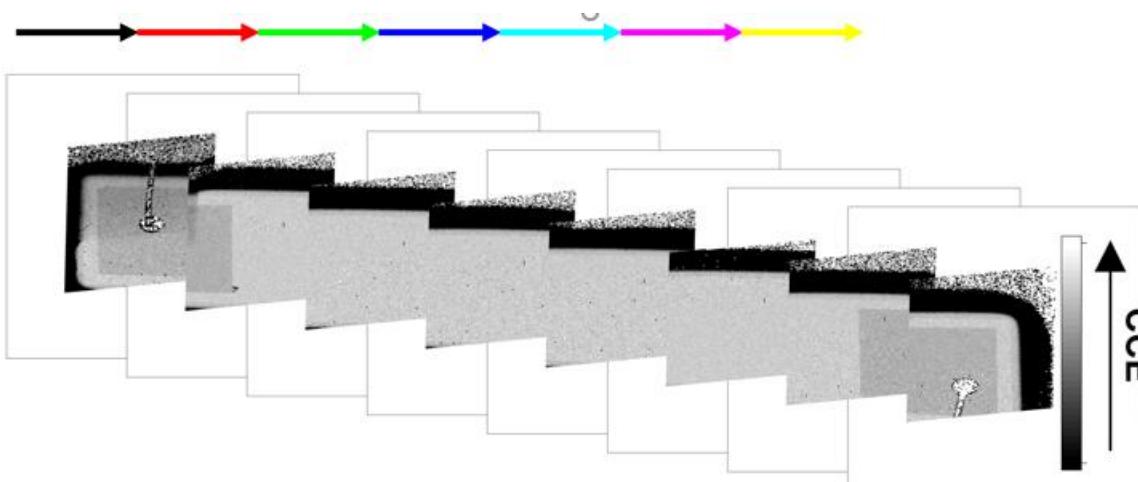
Data Acquisition and Control
software and hardware
SPECTOR



Data Acquisition and Control
software and hardware
SPECTOR

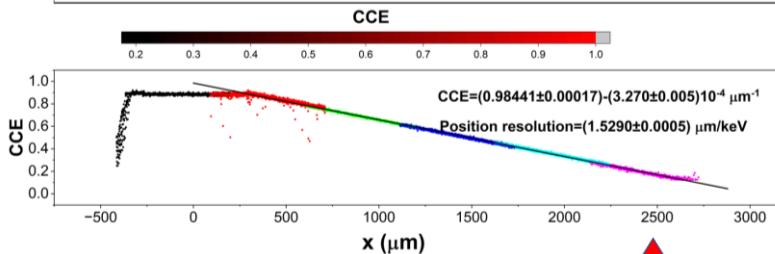


Data Acquisition and Control
software and hardware
SPECTOR

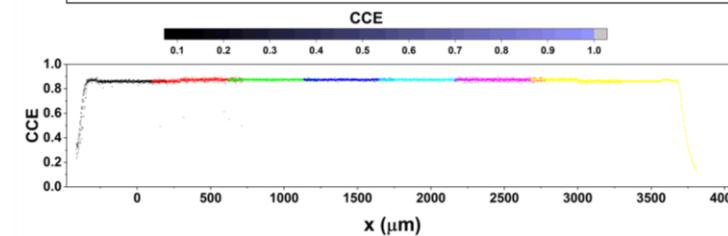
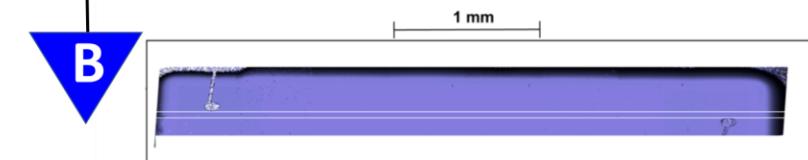
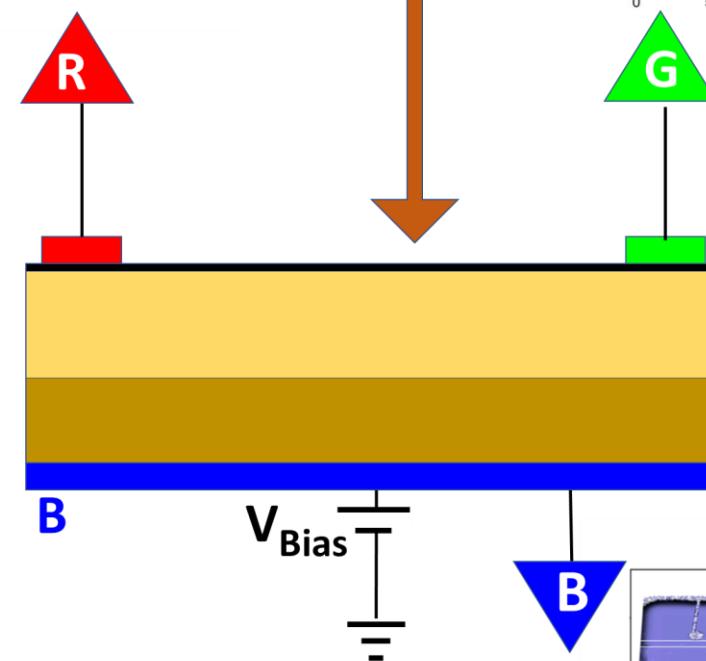
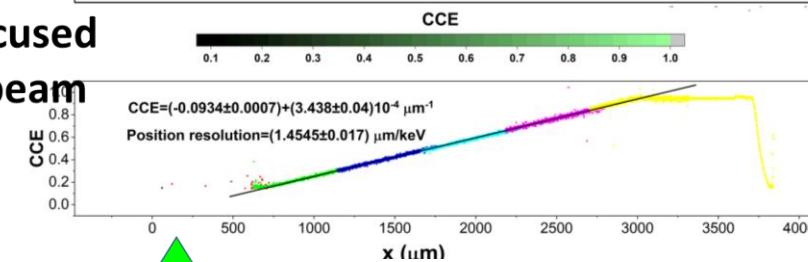
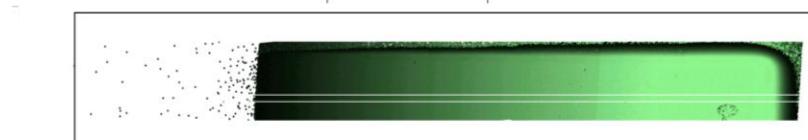


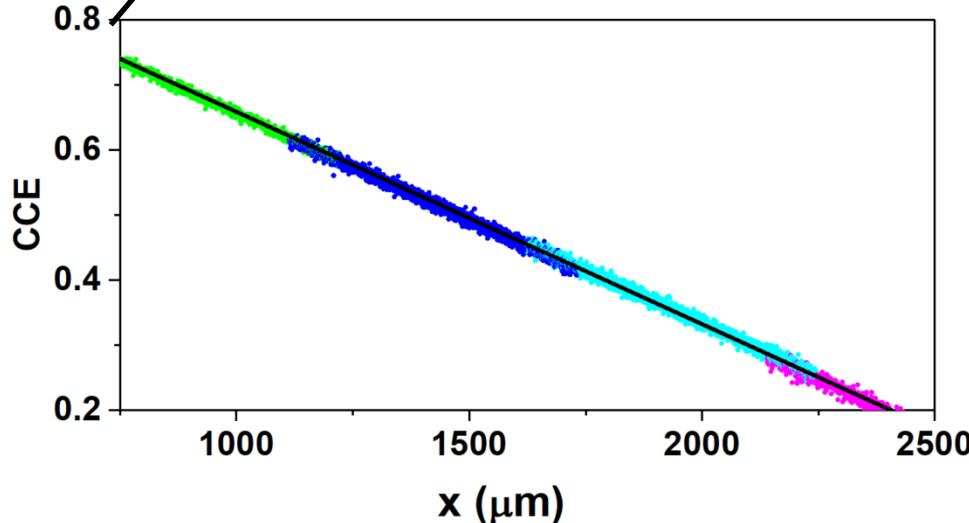
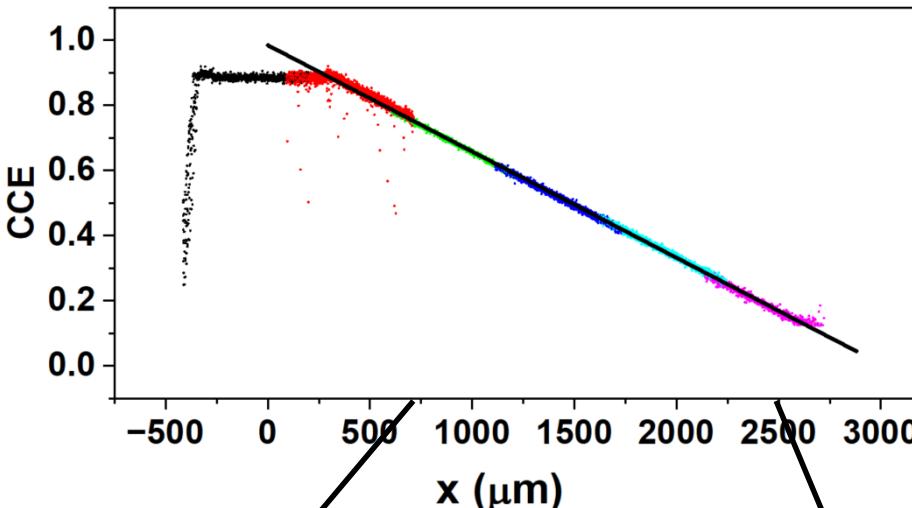
**8 scanning regions
(128x128 pixels)
(500x500) μm^2
Shift: 500 μm**

1 mm

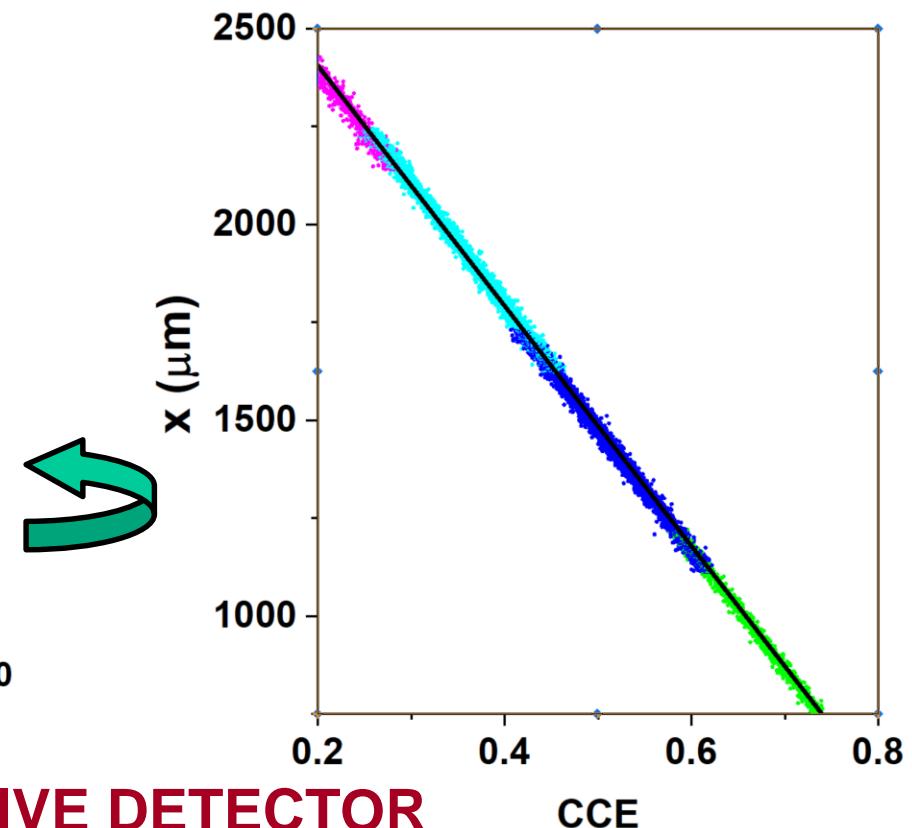
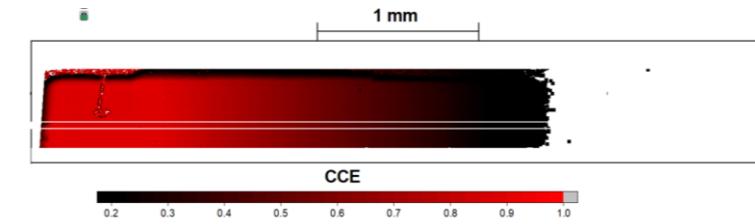


Scanning focused MeV μ -ion beam



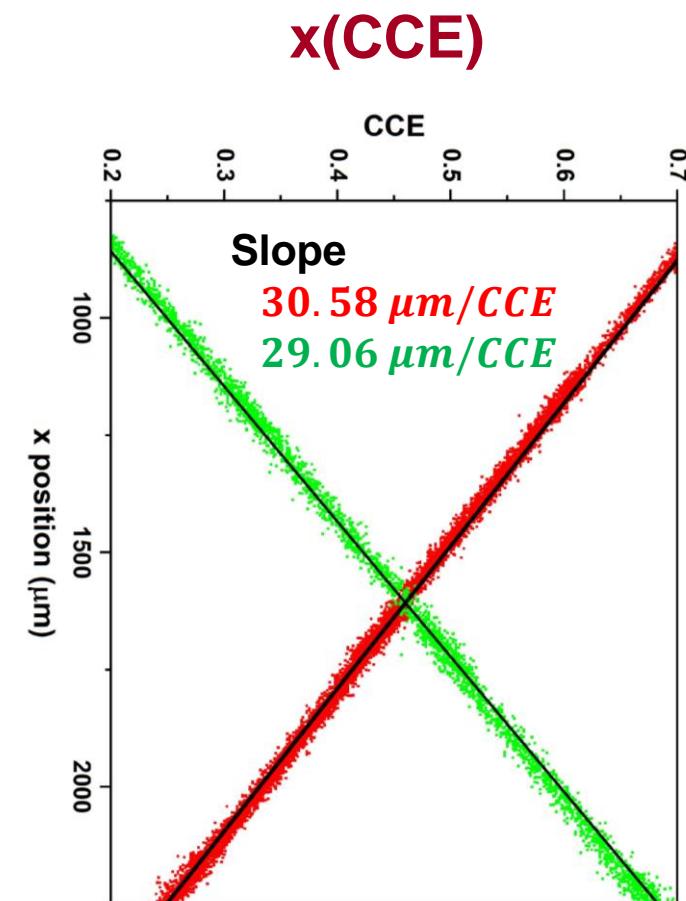
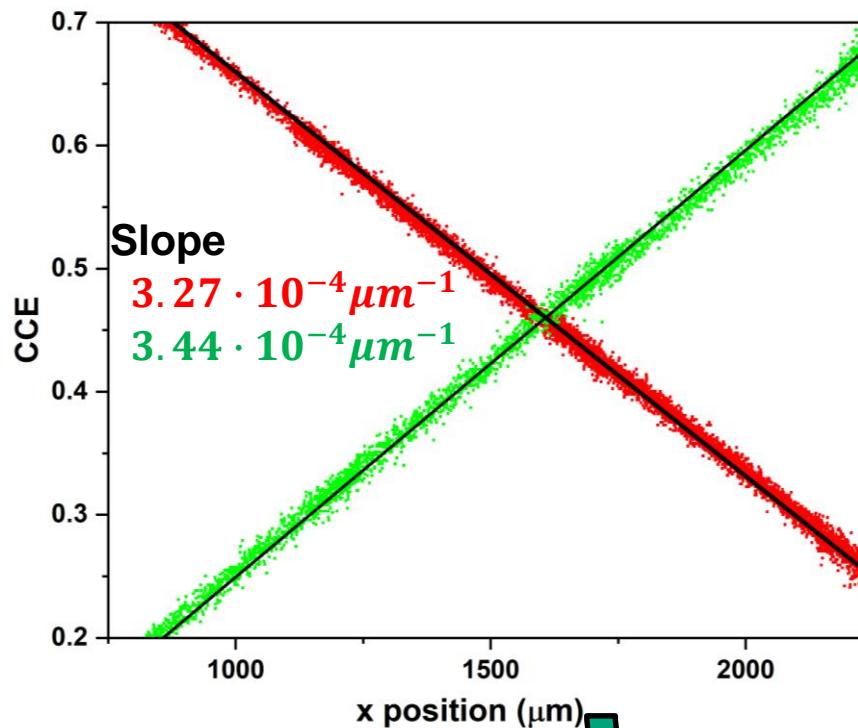


Red Electrode



LINEAR POSITION SENSITIVE DETECTOR

CCE(x)



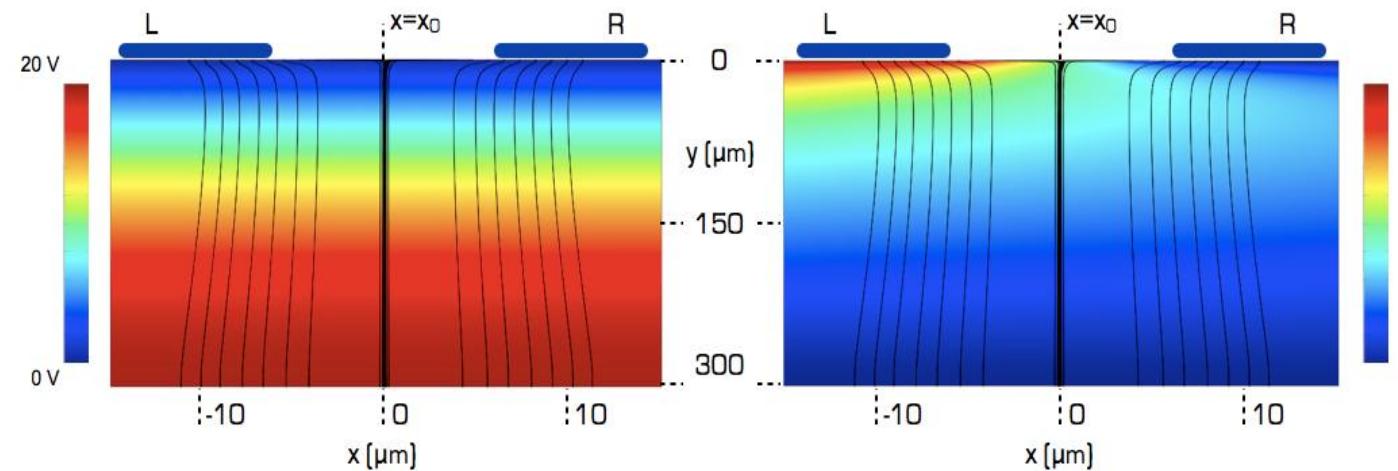
LINEAR POSITION SENSITIVE DETECTOR

Spectral resolution: 34 keV \rightarrow 0.017 CCE \rightarrow 49 μm

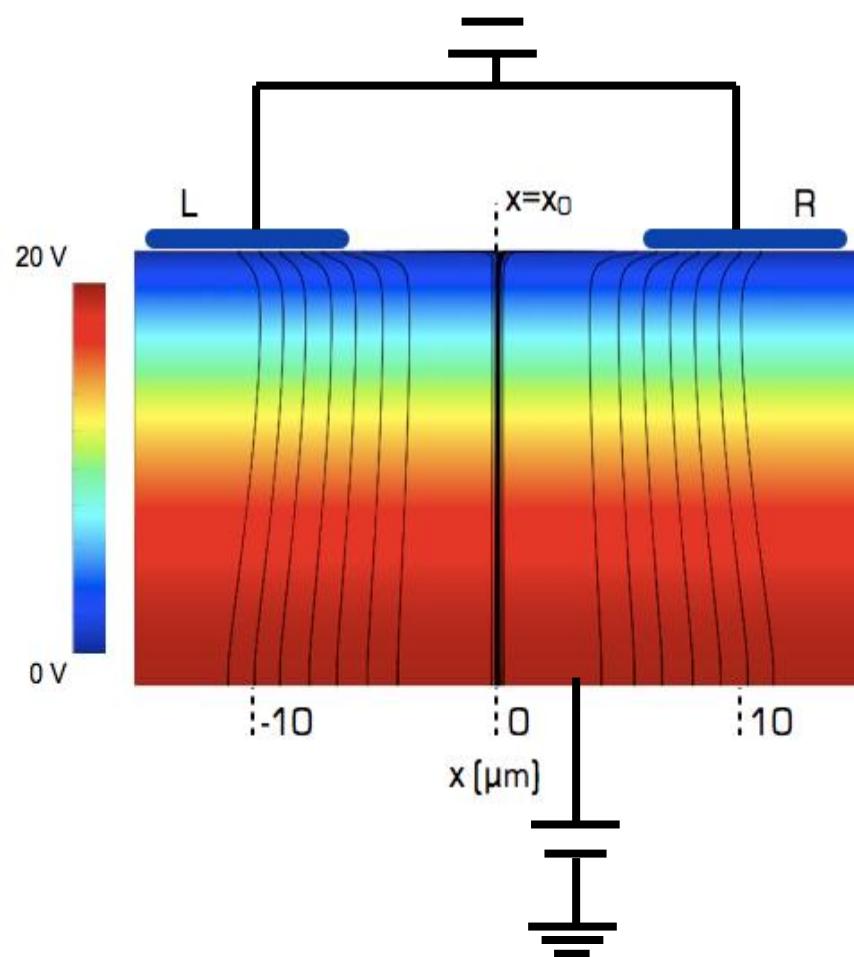
The induced charge Q at the sensing electrode is given by the difference in the weighting potentials between any two positions (r_A and r_B) of the moving charge

$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

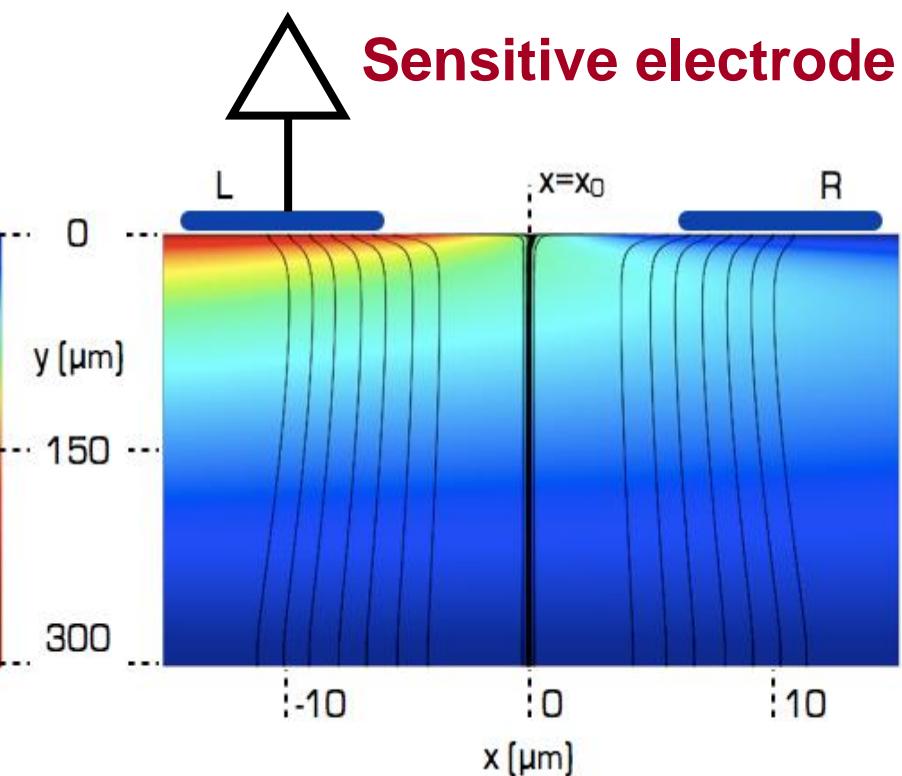
CHARGE SHARING IN MULTIELECTRODE DEVICES



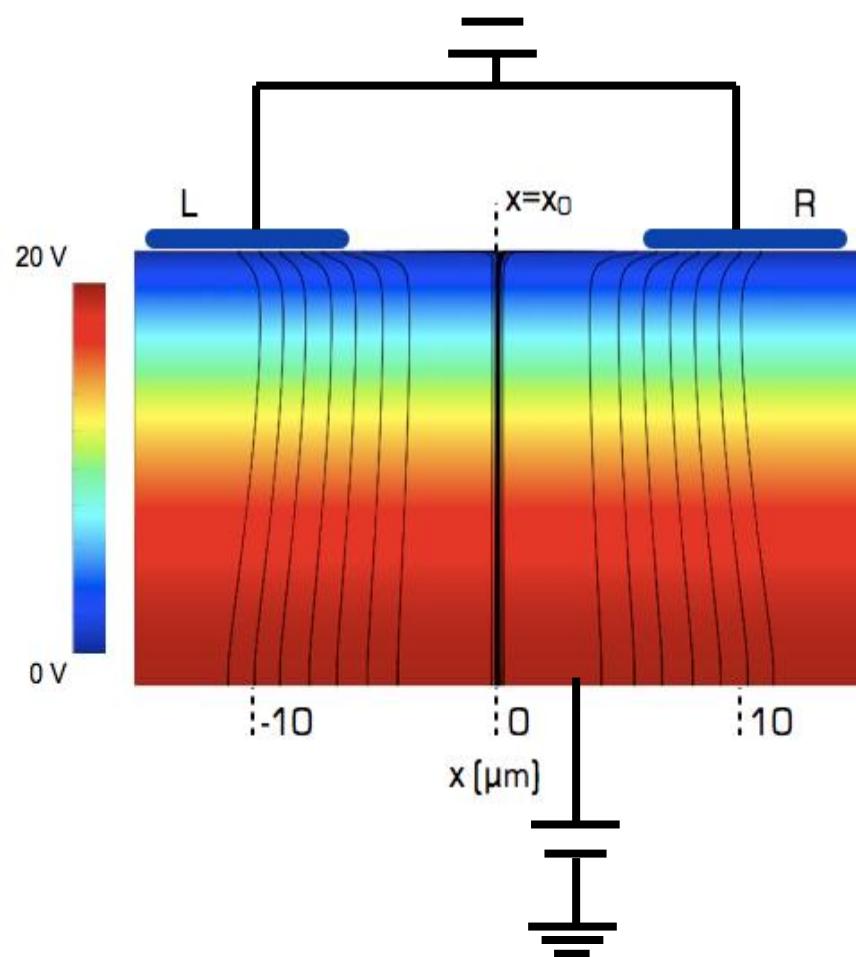
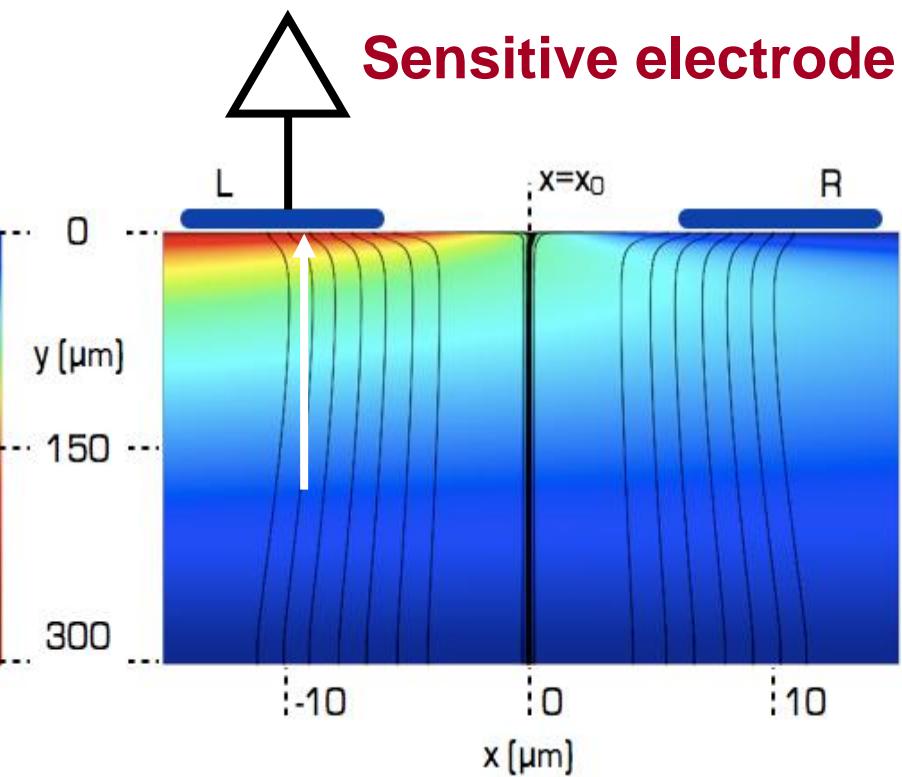
Actual potential



Weighting potential

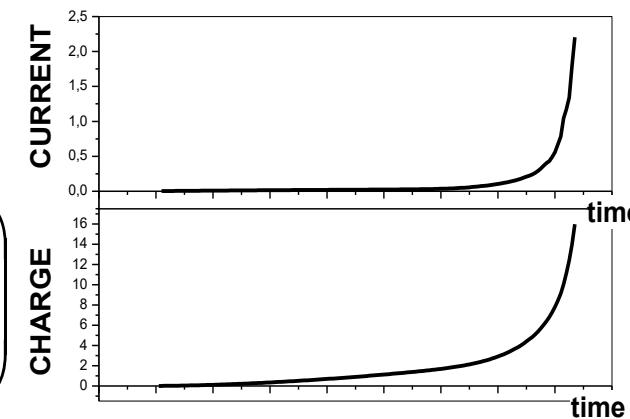


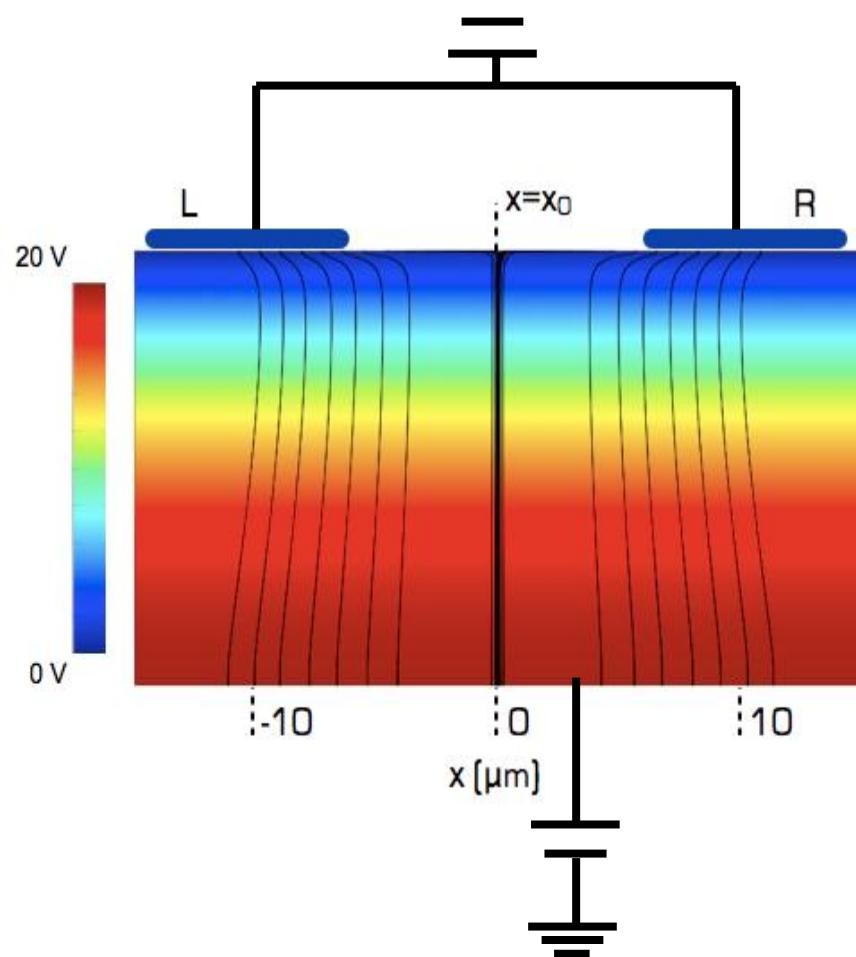
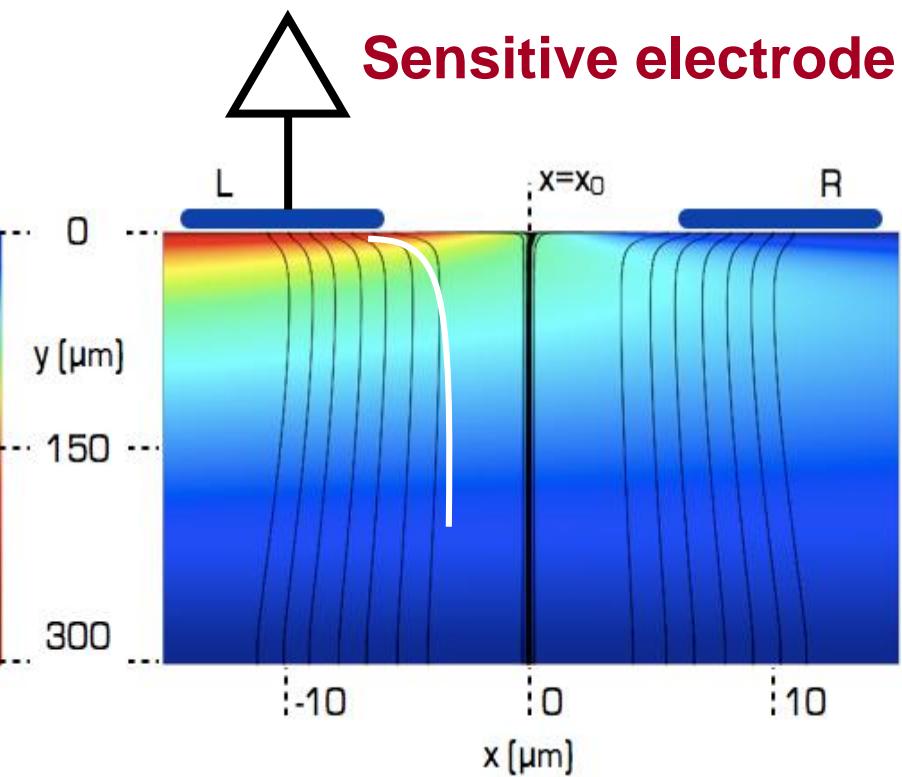
Sensitive electrode

Actual potential**Weighting potential**

$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

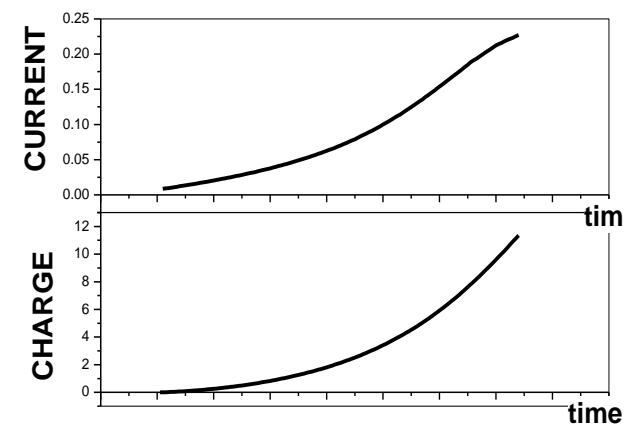
Single Ion Detection



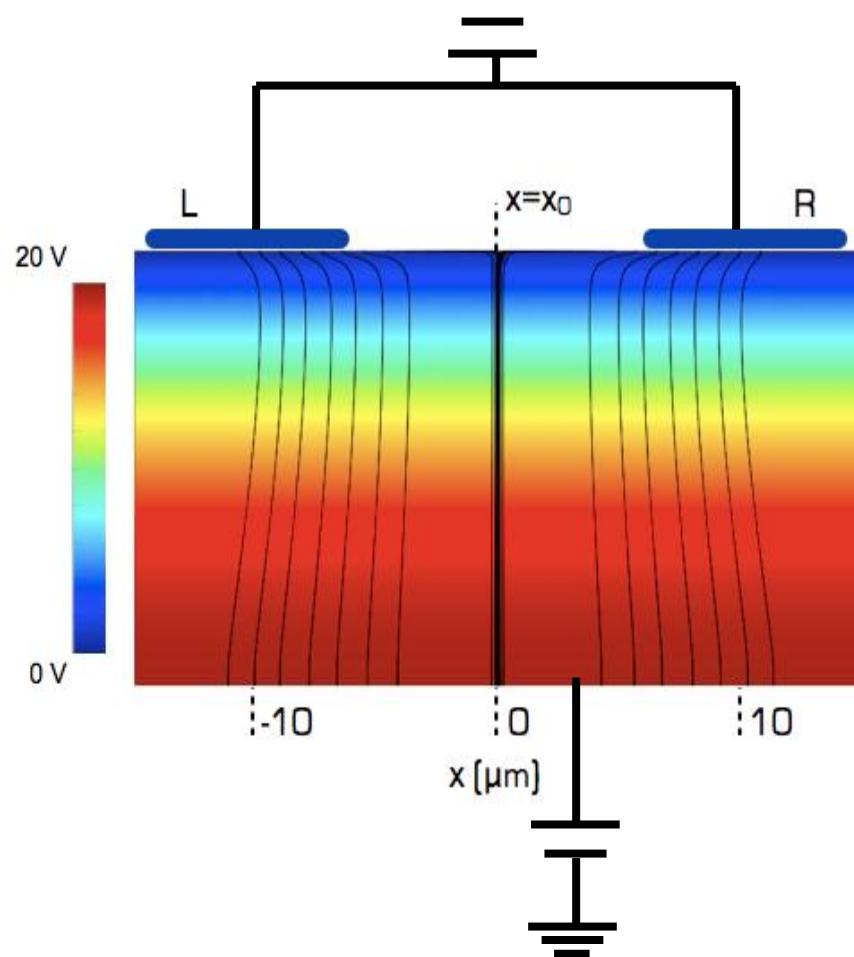
Actual potential**Weighting potential****Sensitive electrode**

$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

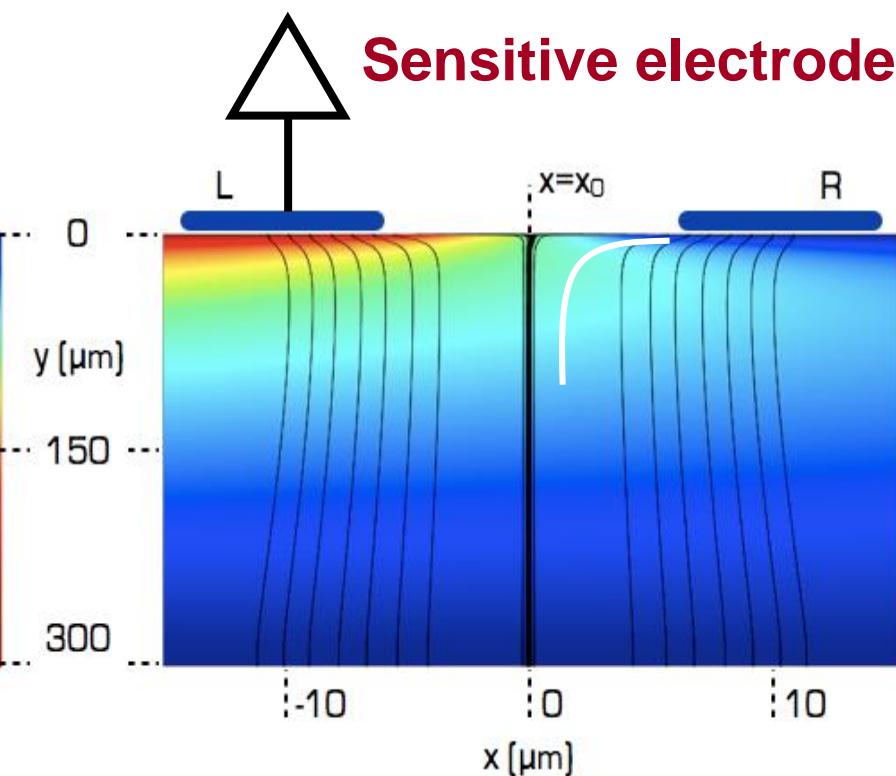
Single Ion Detection



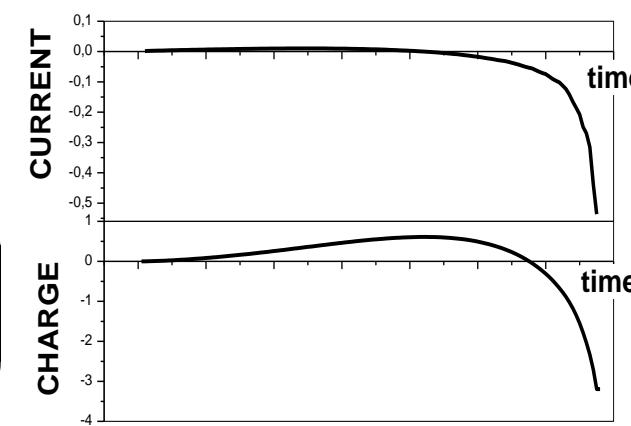
Actual potential



Weighting potential



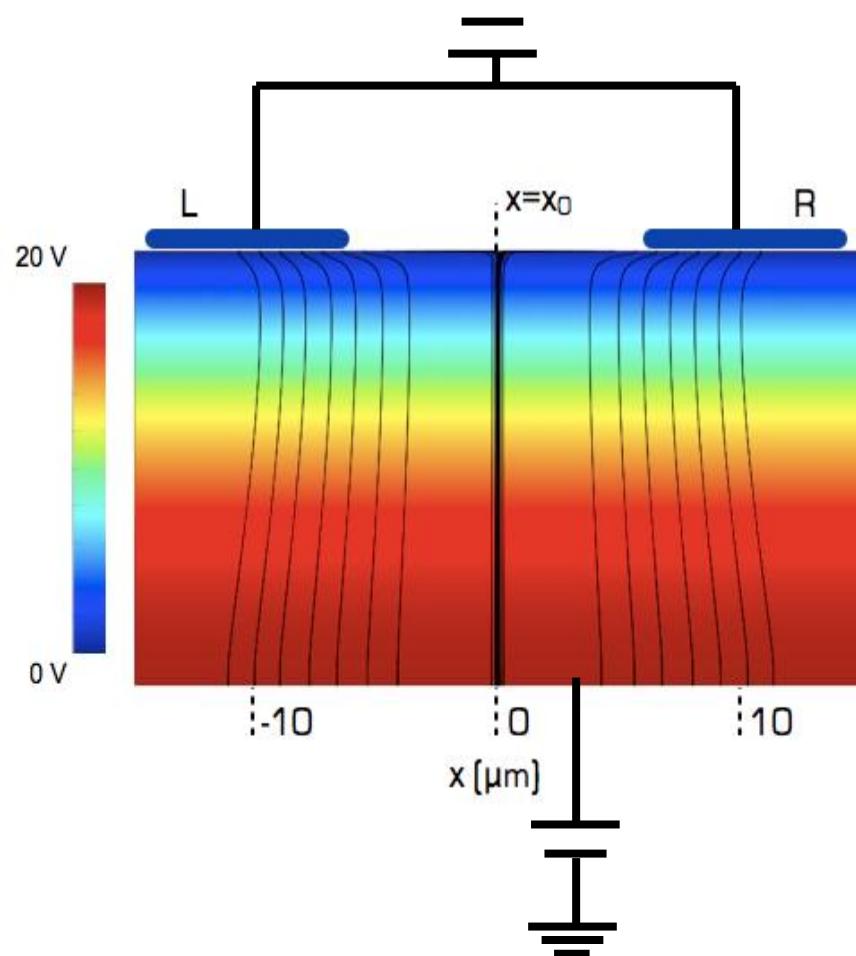
Sensitive electrode



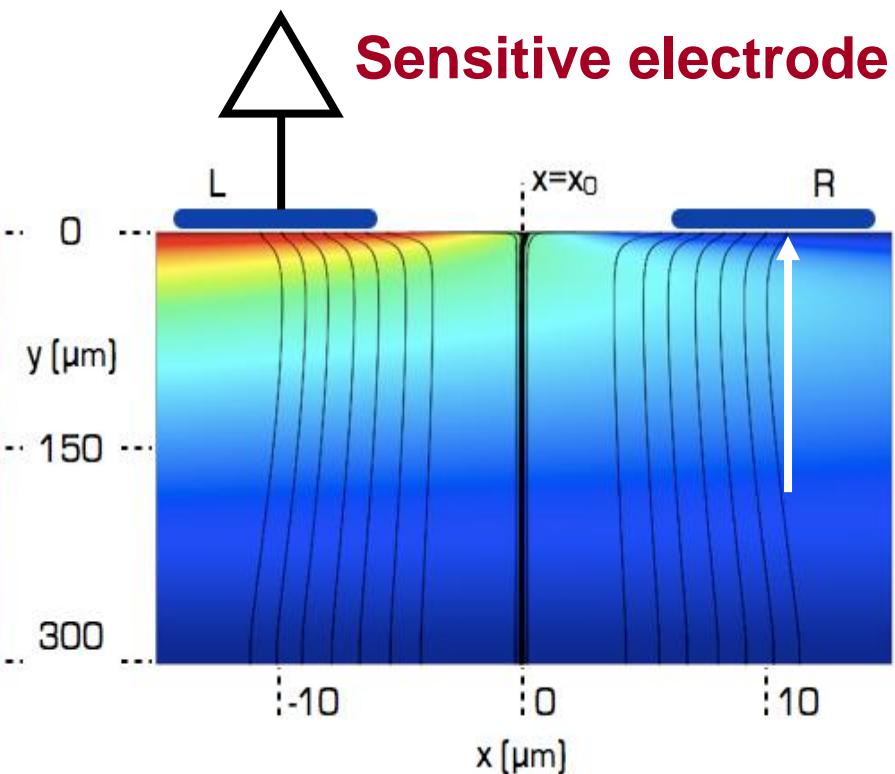
$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

Single Ion Detection

Actual potential

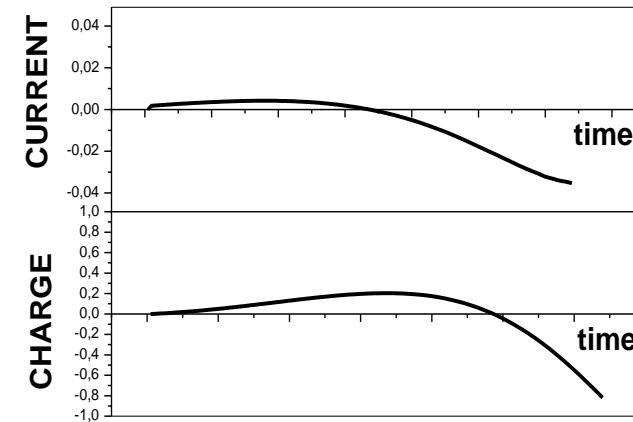


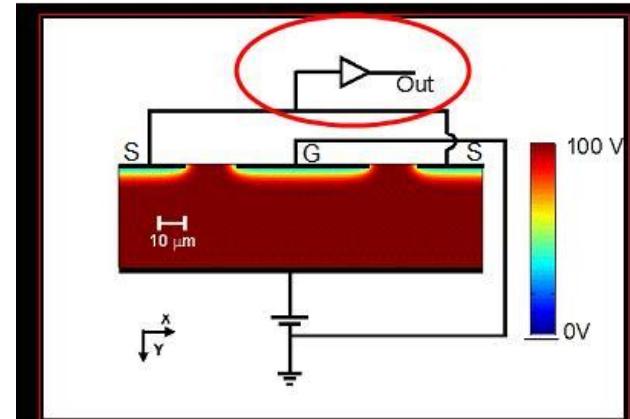
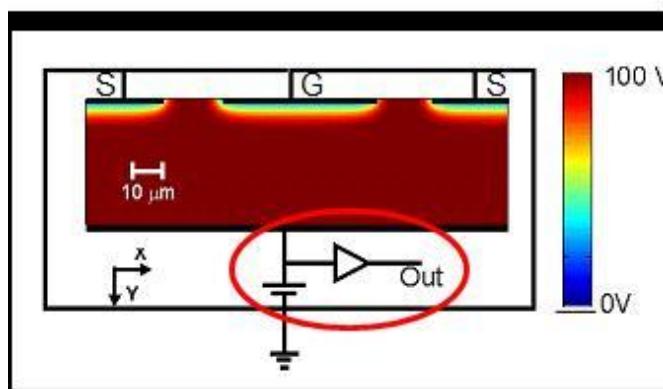
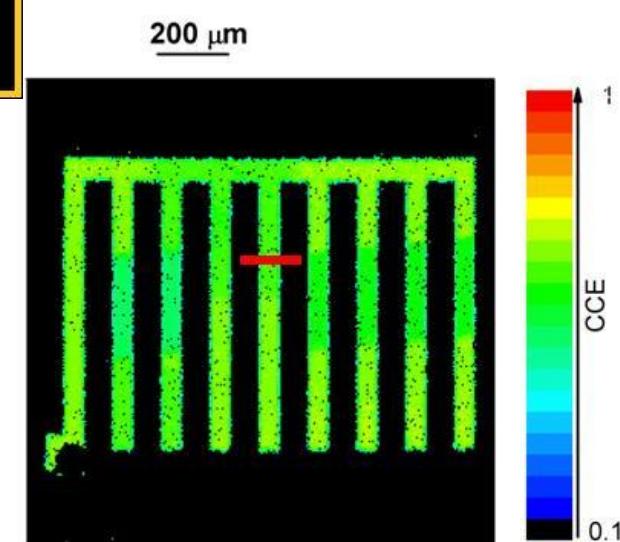
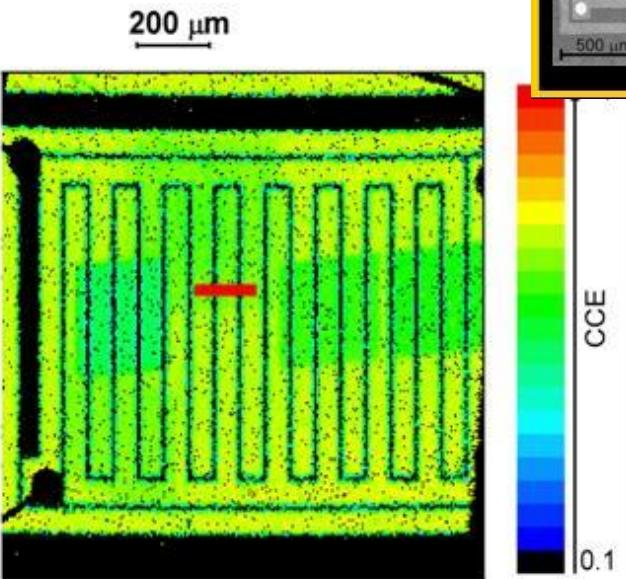
Weighting potential

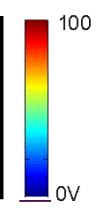
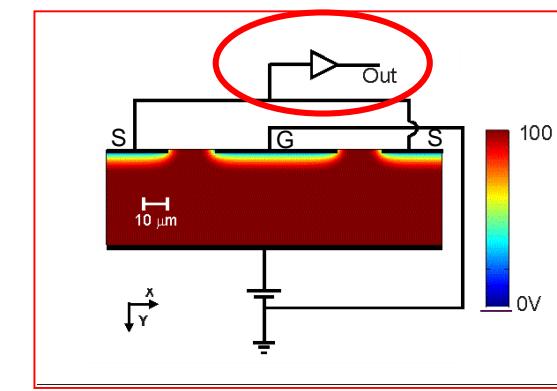
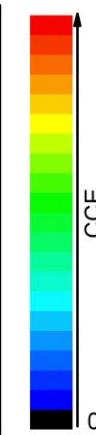
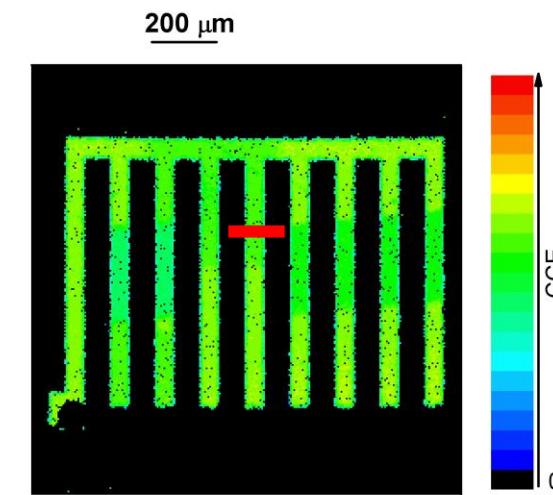
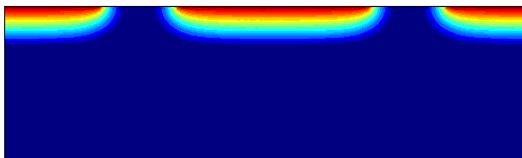
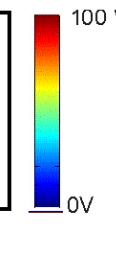
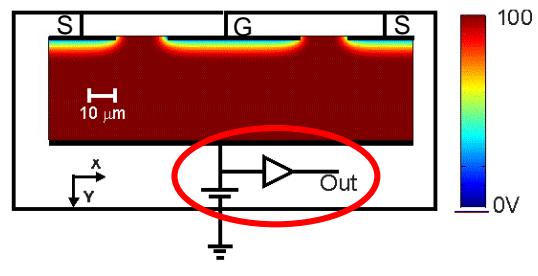
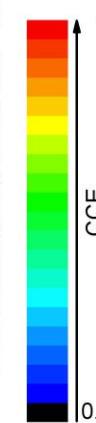
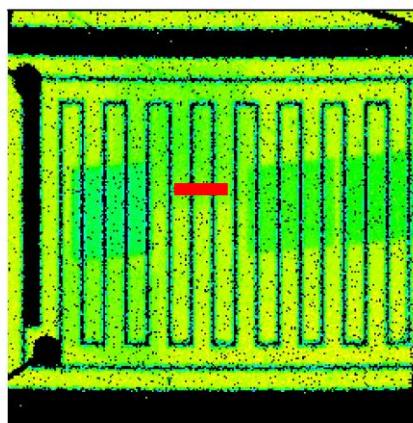


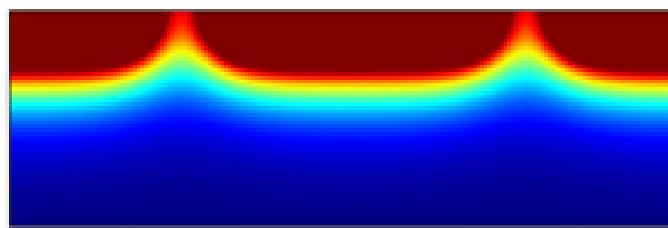
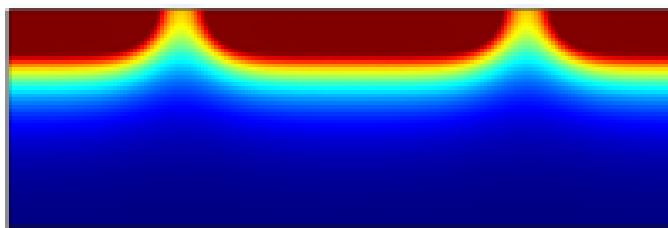
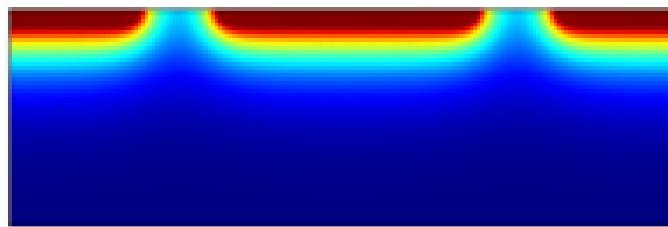
$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

Single Ion Detection

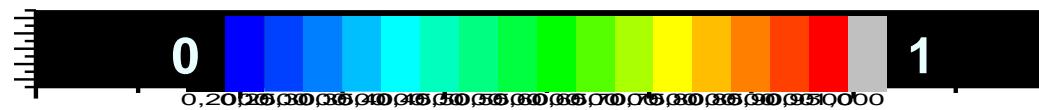




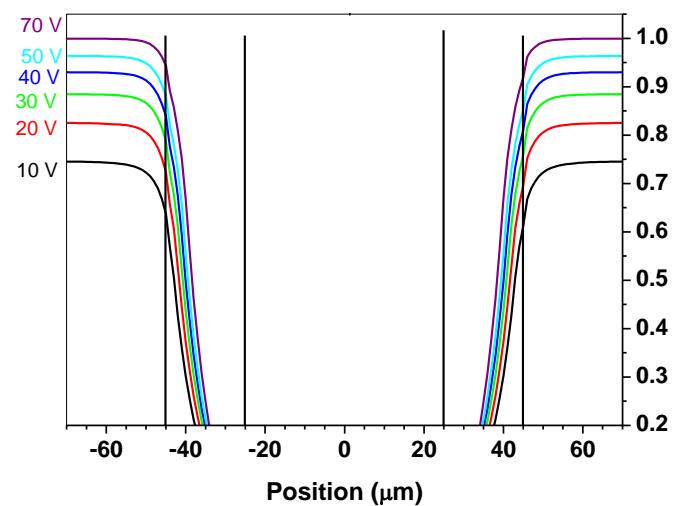
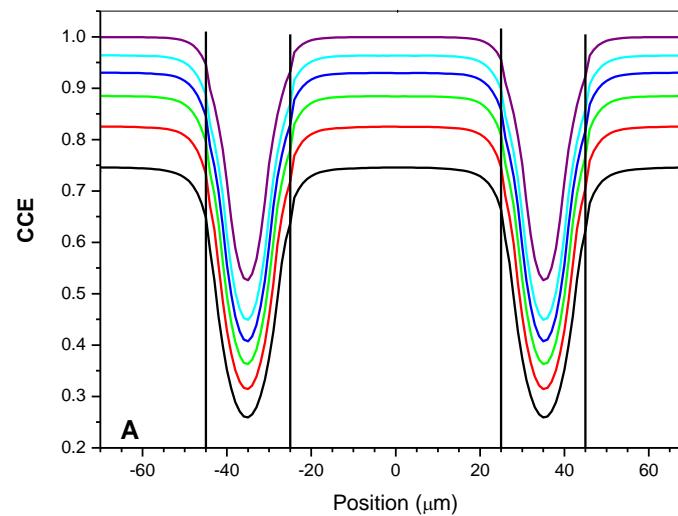
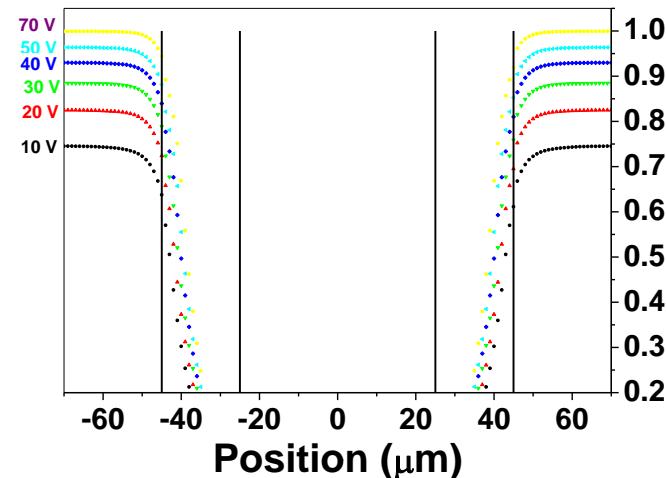
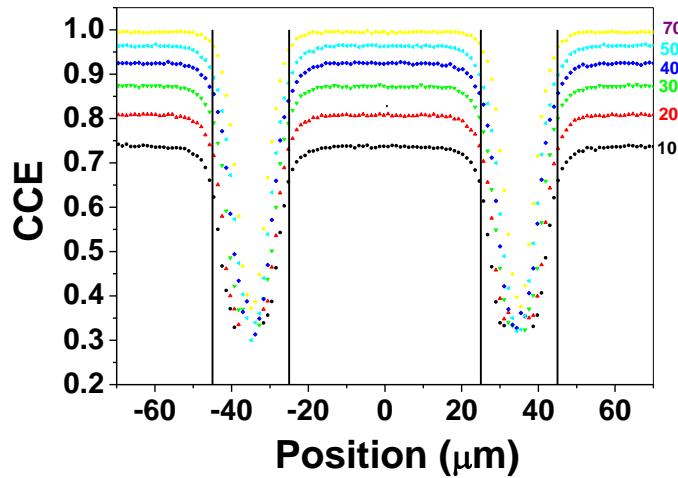
200 μm 



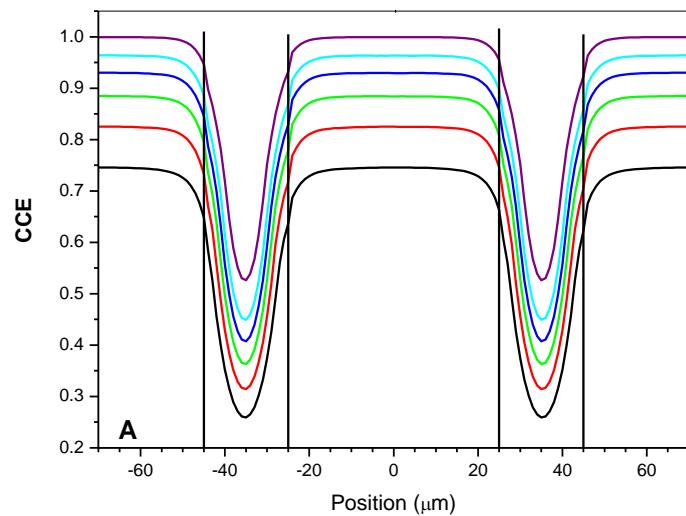
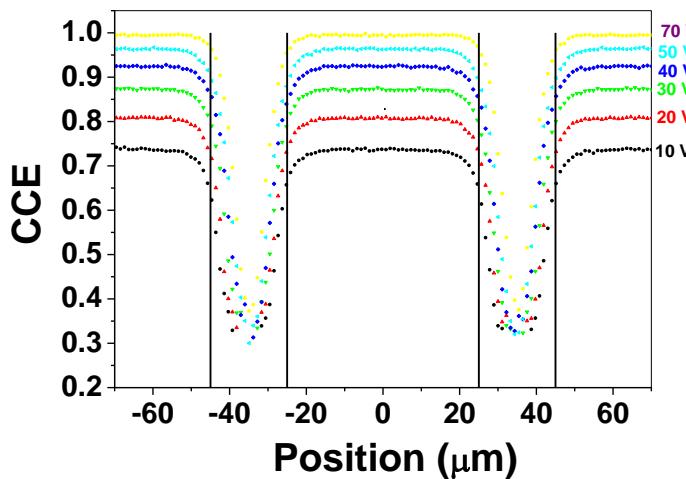
CCE



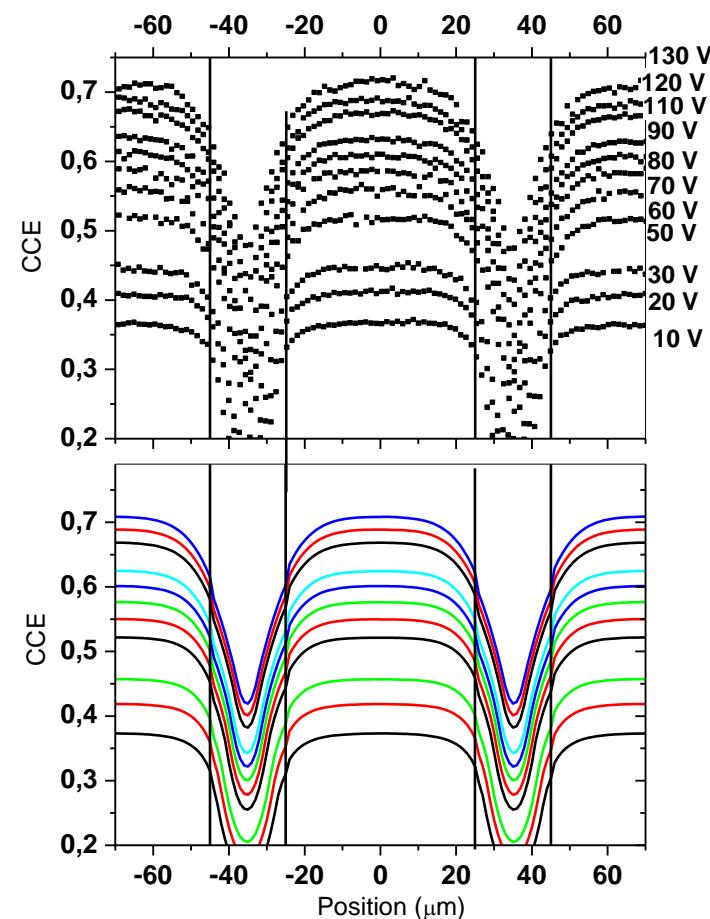
0.9 MeV protons



0.9 MeV protons

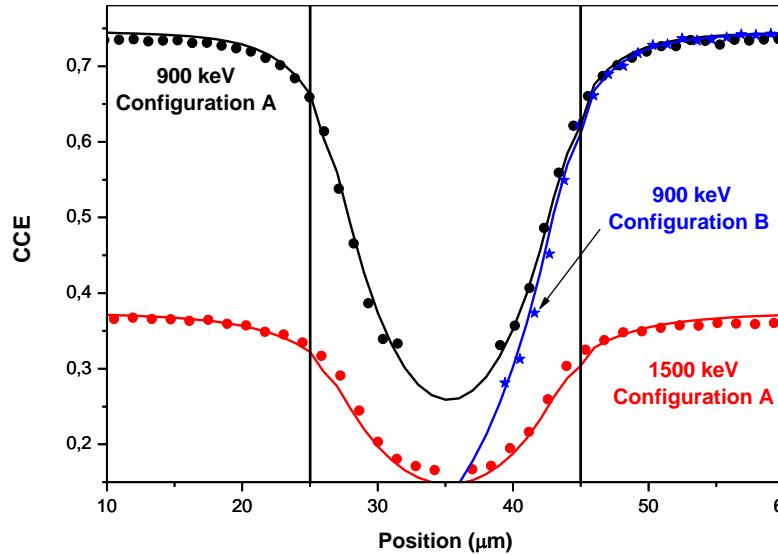


1.5 MeV protons

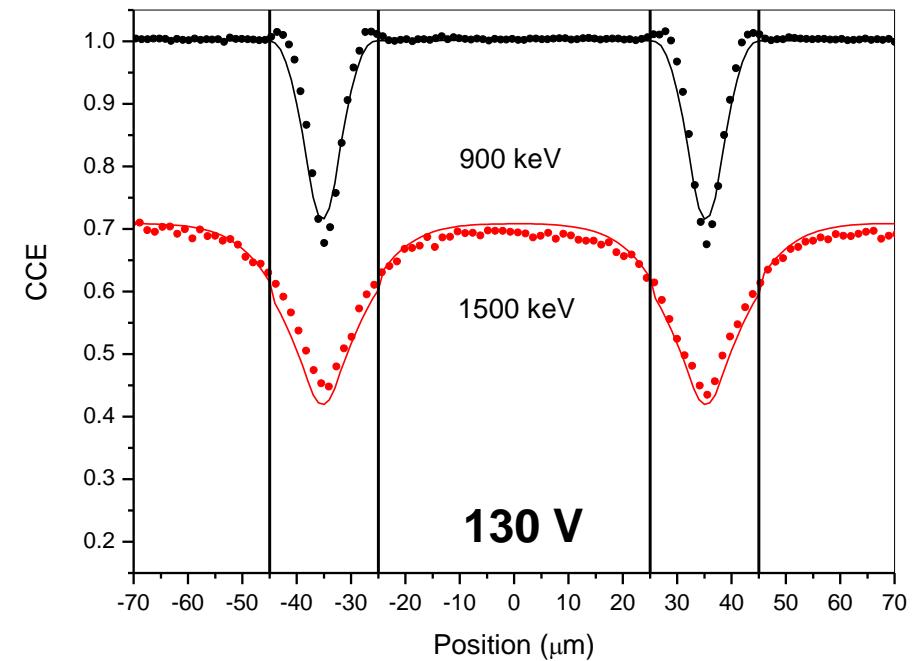
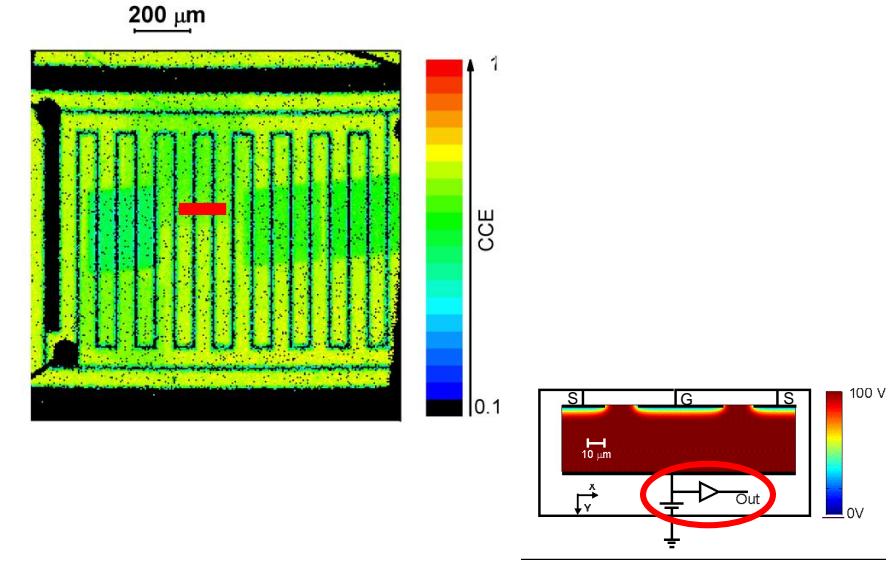


CCE profile details

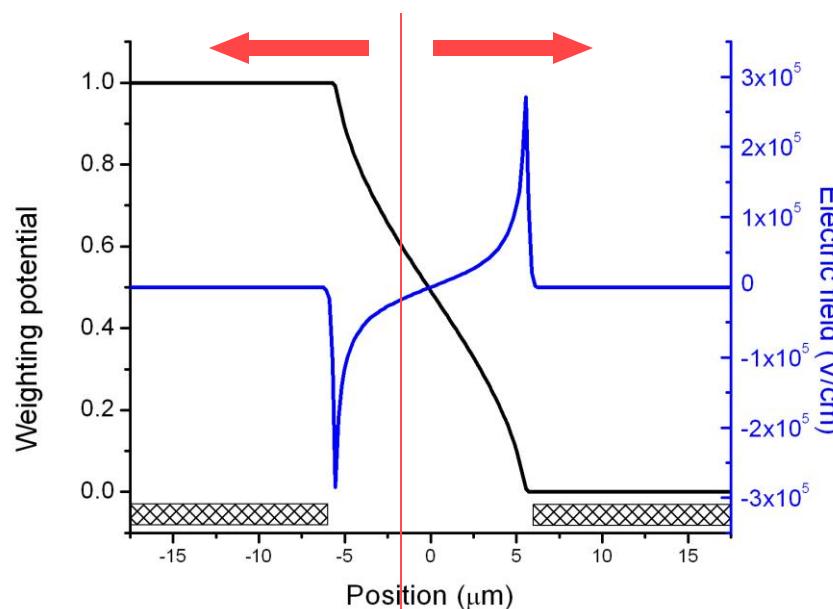
hole diffusion length = $8.7 \mu\text{m}$.
 hole lifetime = $\tau_p = 250 \text{ ns}$



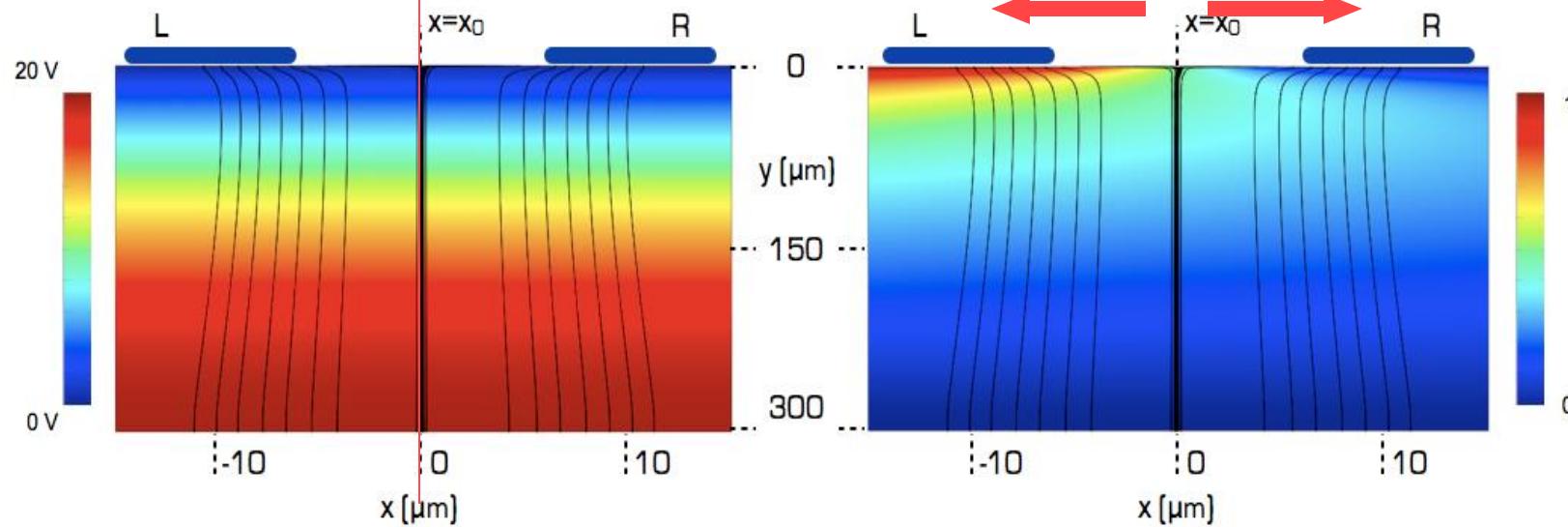
The electrode edges
are highlighted by the
vertical black line.

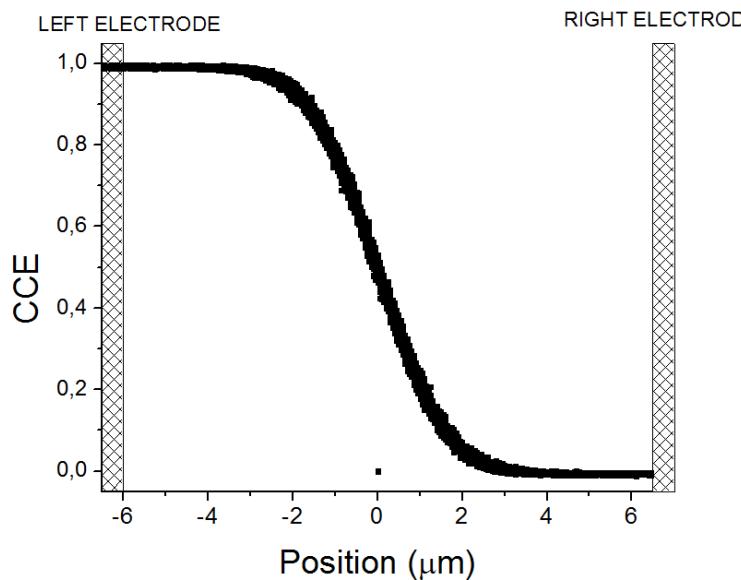


Horizontal electric field

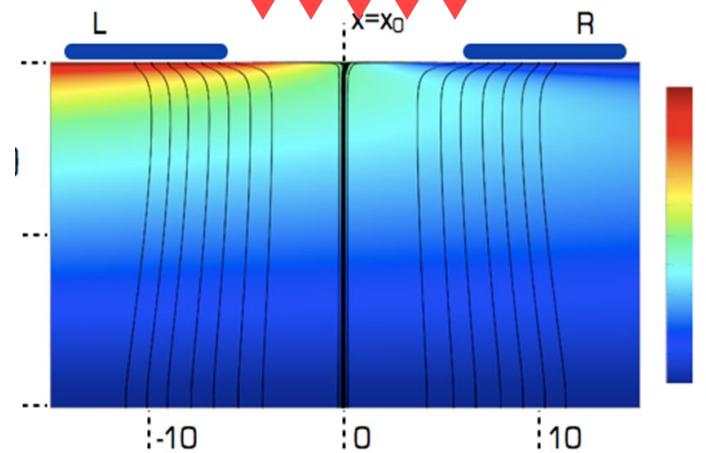


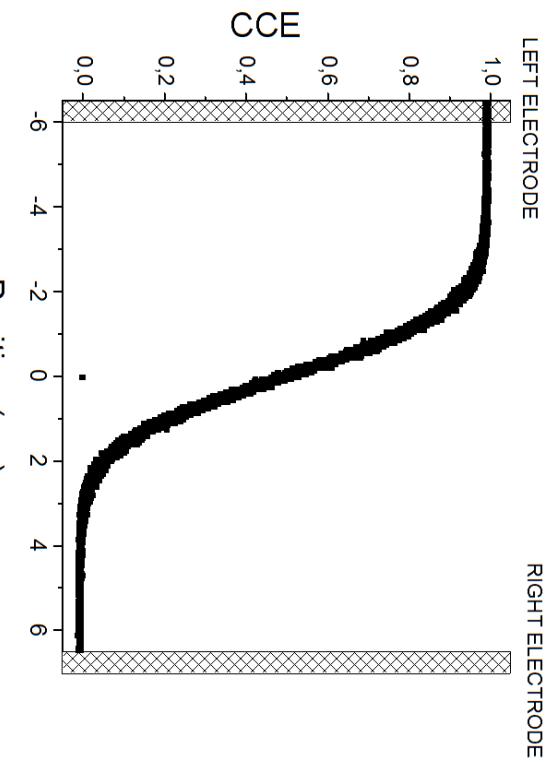
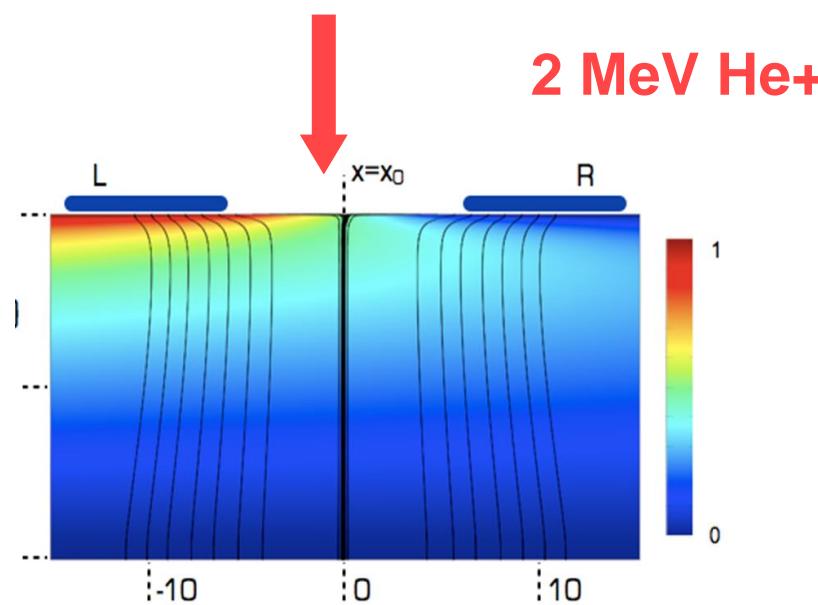
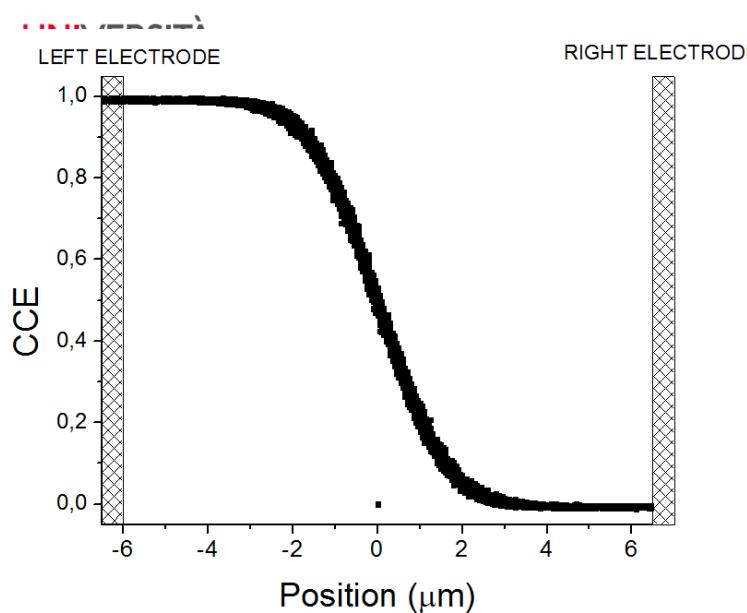
$$Q = q \cdot \left(\frac{\partial \psi}{\partial V} \Big|_{\text{final position}} - \frac{\partial \psi}{\partial V} \Big|_{\text{initial position}} \right)$$

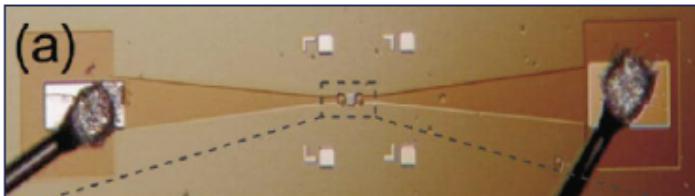




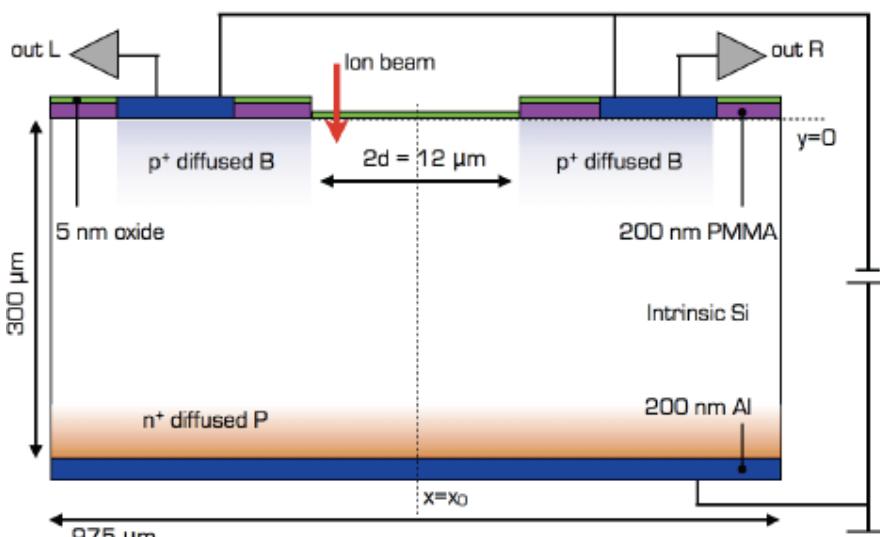
2 MeV He+



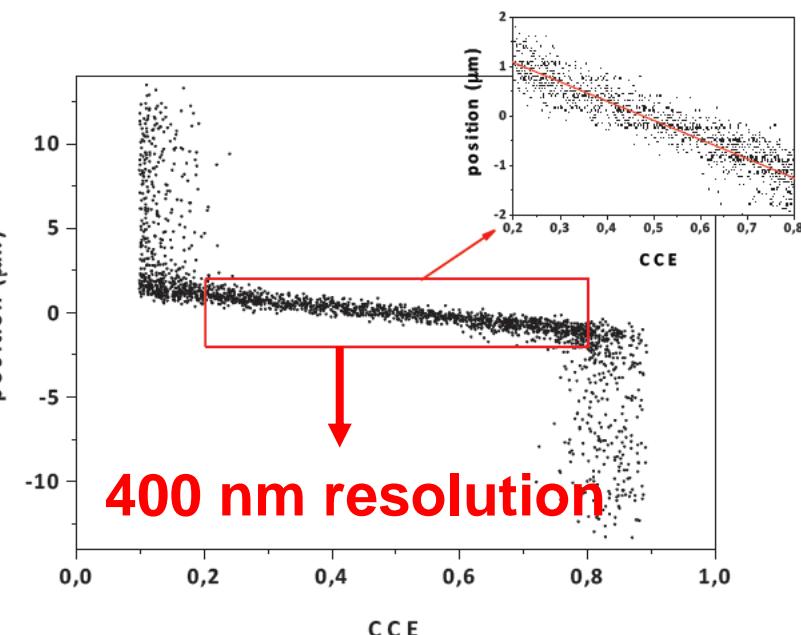




Top view



**2 MeV He beam @ NEC 5I
Pelletron, Melbourne
1 μm spot size**



**A SUB-MICROMETER POSITION
SENSITIVE DETECTOR**



A multi-electrode two-dimensional position-sensitive diamond detector

Ditalia Tchernij et al. Applied Physics Letters 2024, 124(22), 223502

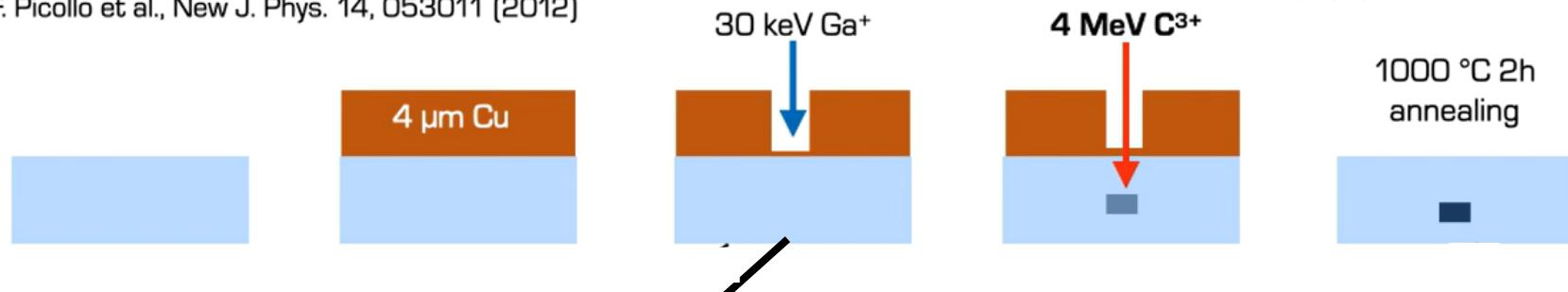
Graphite-diamond-graphite device fabrication

Deep Ion Beam Lithography

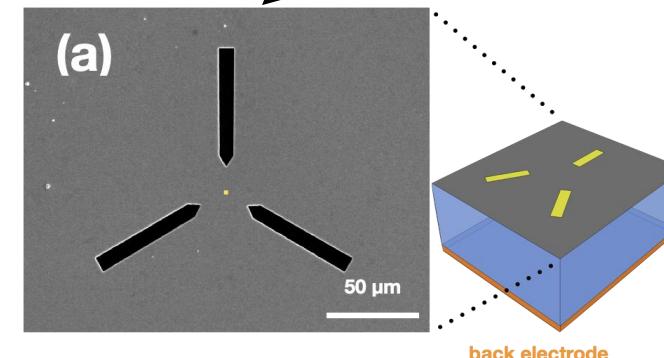
Exploitation of **MeV** ion nuclear energy loss
Cumulation of **damage** at the **end of ion range**
Amorphization of buried diamond layer

Thermal treatment: **Conductive channels** embedded in **insulating diamond**, high dielectric strength

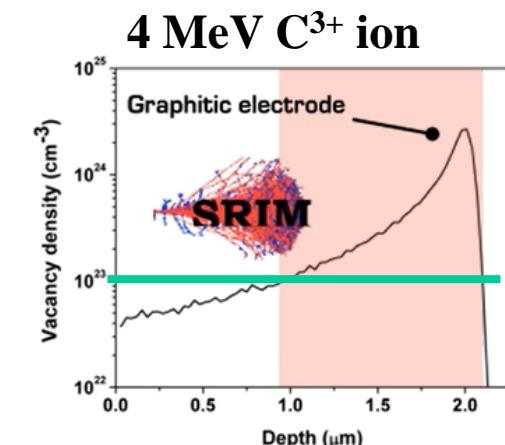
F. Picollo et al., New J. Phys. 14, 053011 (2012)



**3×3×0.3 mm³ synthetic
“electronic grade” <100>
single-crystal diamond
substrate**



**~1 μm thick
graphitic electrodes
at
1.5 μm depth from
the diamond
surface**

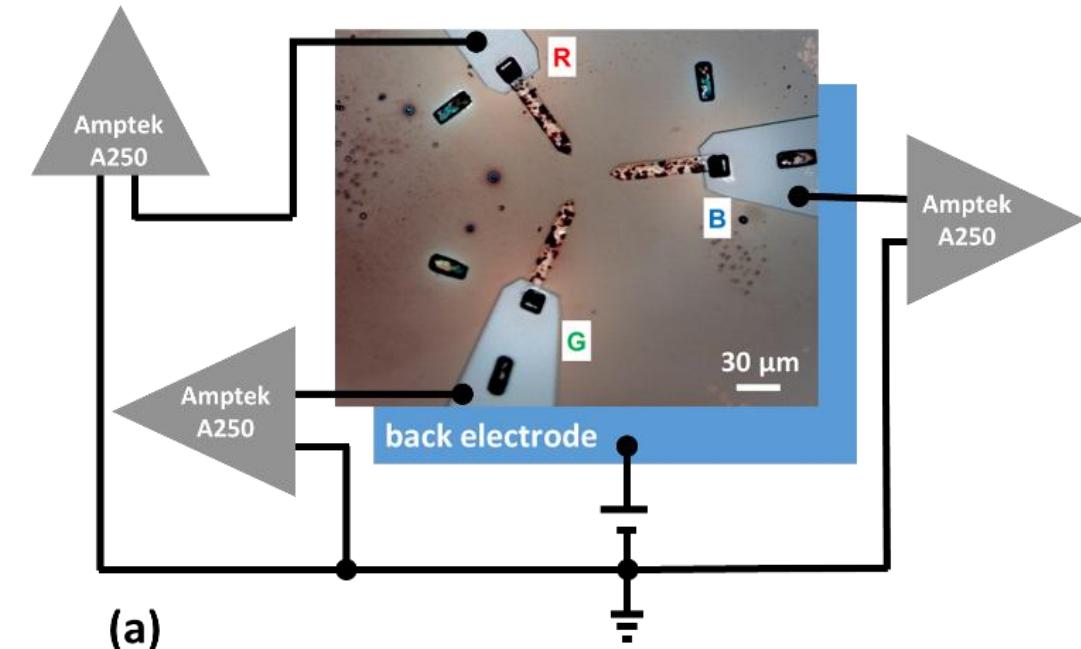


1000 °C 2h
annealing

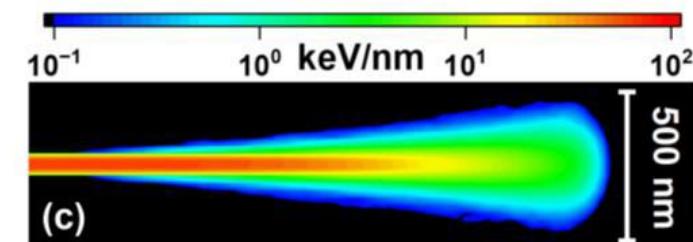
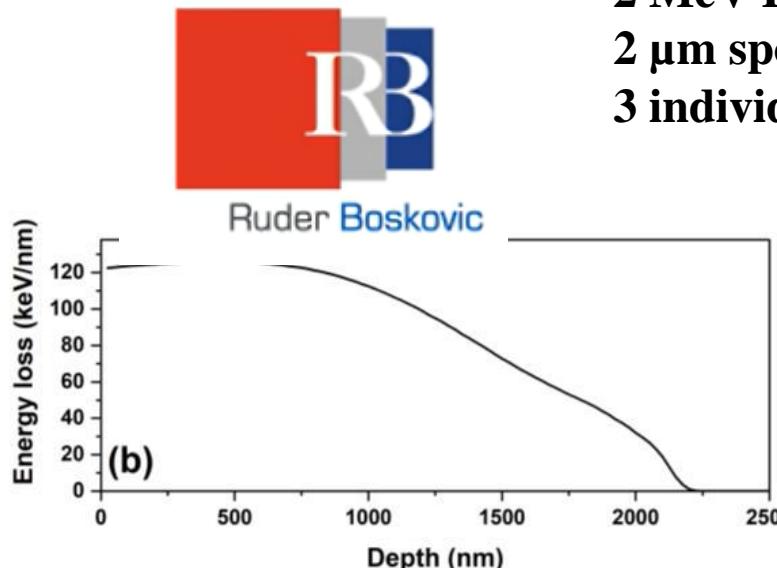
The IBIC experiment

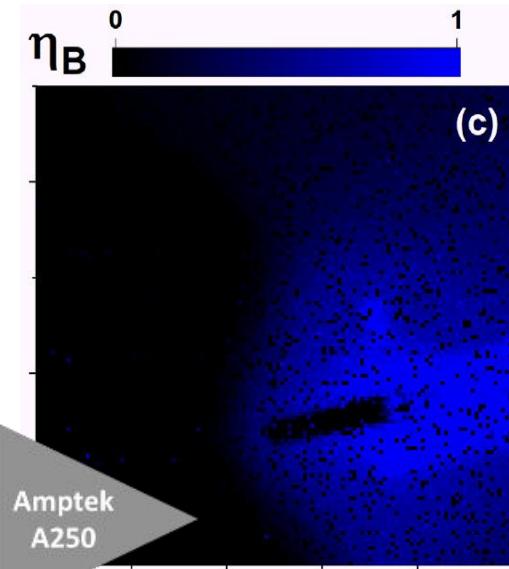
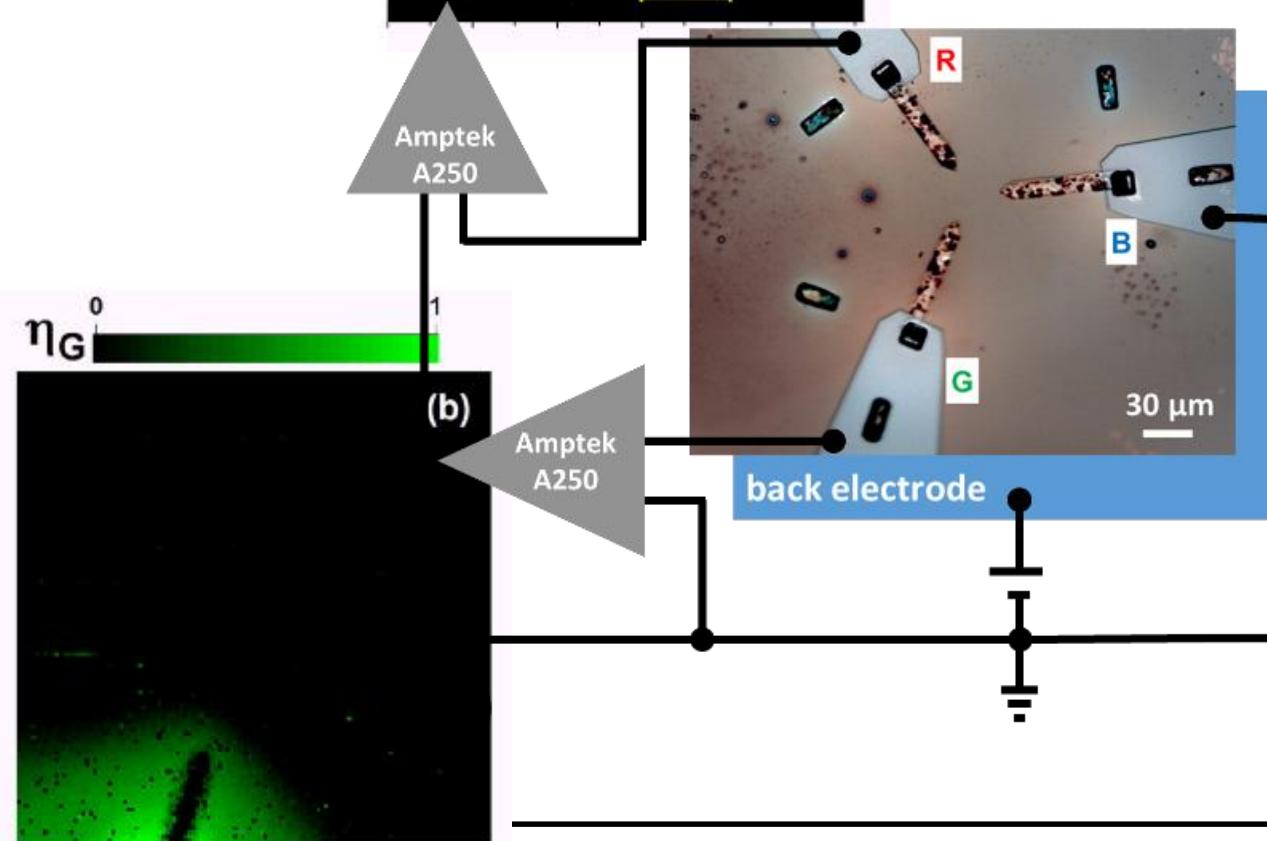
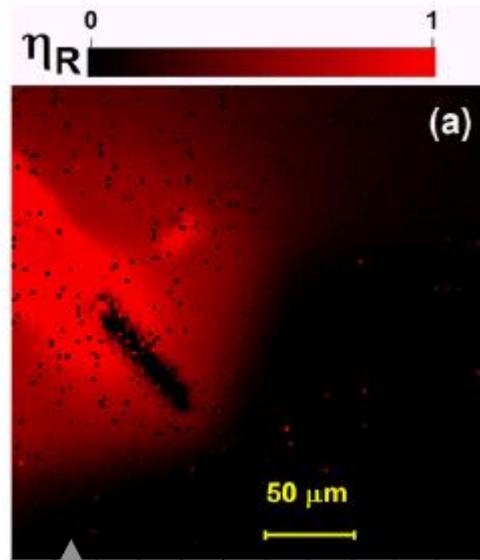
3 independent sensing electrodes
5 μm wide, 75 μm long
26 μm equilateral triangle
1 common back electrode

Amptek A250 preamplifier
Ortec 570 shaping amplifier
MCA interfaced with SPECTOR
Bias voltage= 60 V



2 MeV Li microbeam
2 μm spot size
3 individual 128x128 IBIC maps

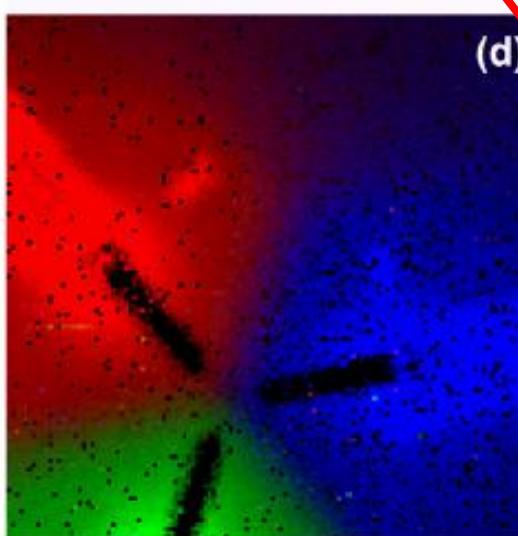




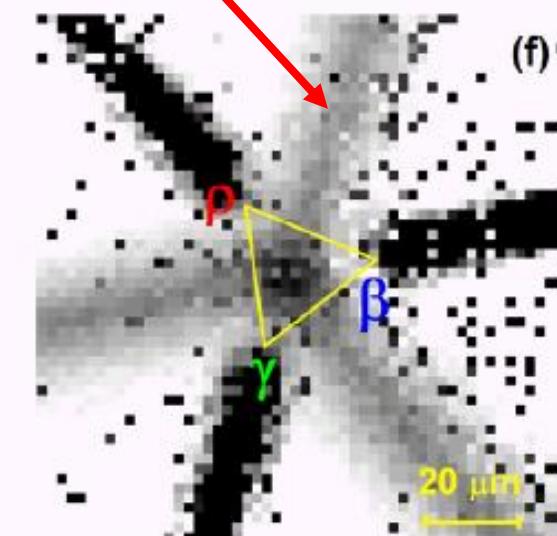
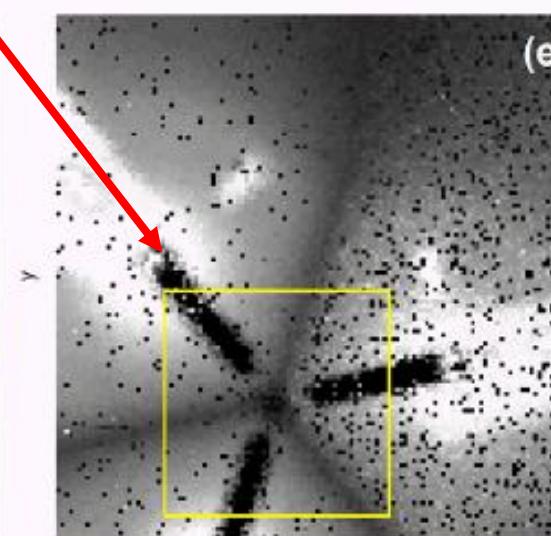
Snowflake's sixfold symmetry

Three main arms are the graphitic channels

three main arms correspond to the regions where charge sharing occurs between two adjacent electrodes.

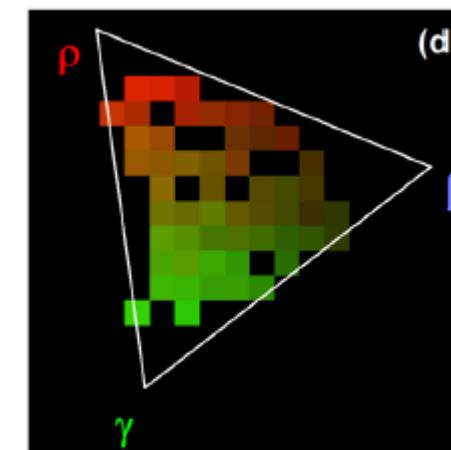
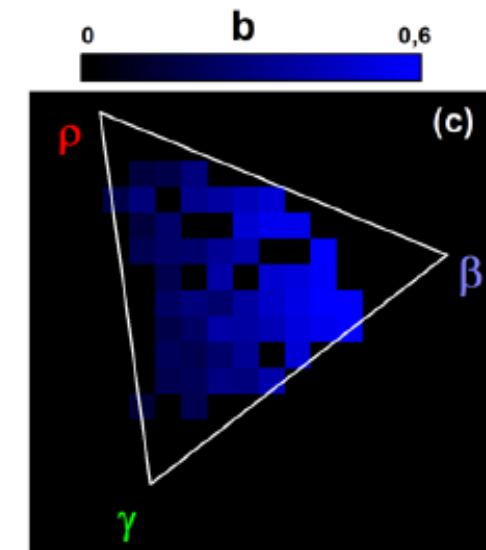
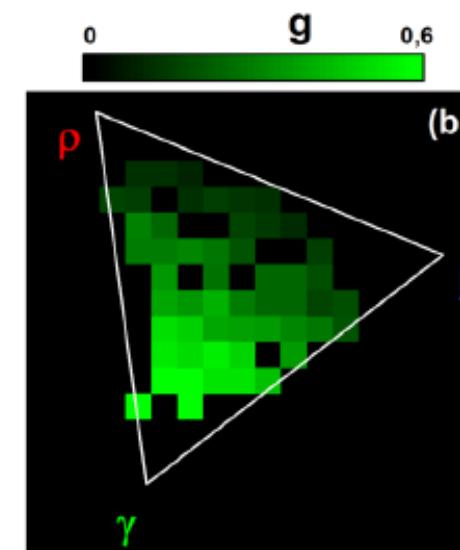
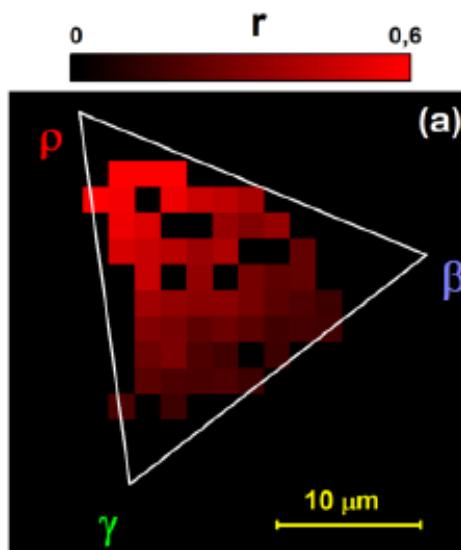


RGB

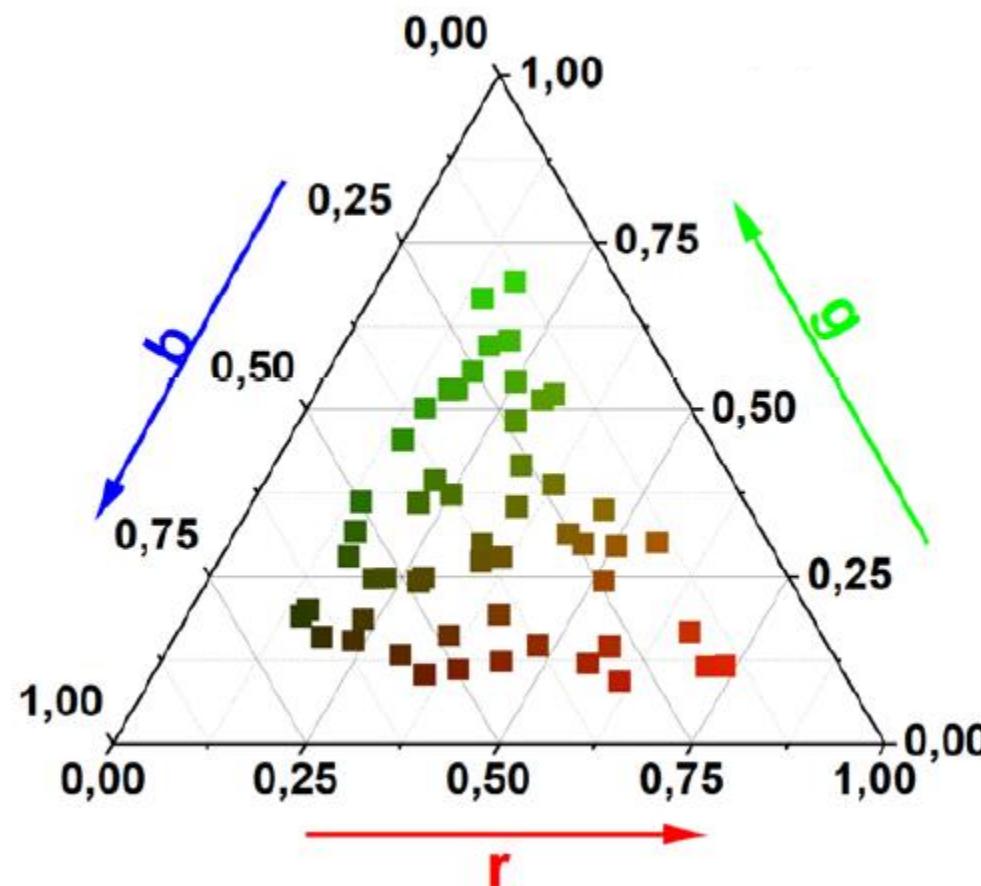


Chroma (absolute color purity)
 $Max(\eta_{R,G,B}) - min(\eta_{R,G,B})$

$$r = \frac{\eta_R}{(\eta_R + \eta_G + \eta_B)}; g = \frac{\eta_G}{(\eta_R + \eta_G + \eta_B)}; b = \frac{\eta_B}{(\eta_R + \eta_G + \eta_B)}$$



The charge space

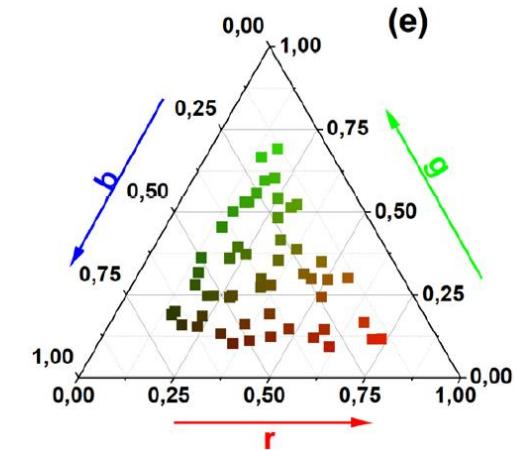
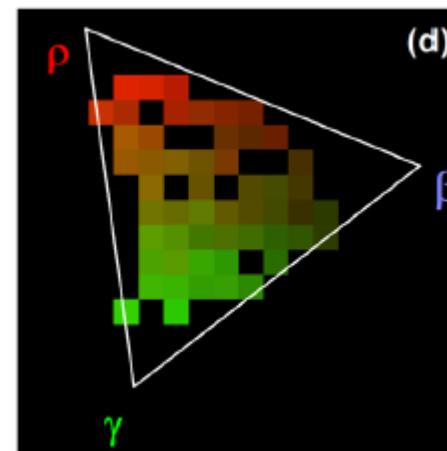
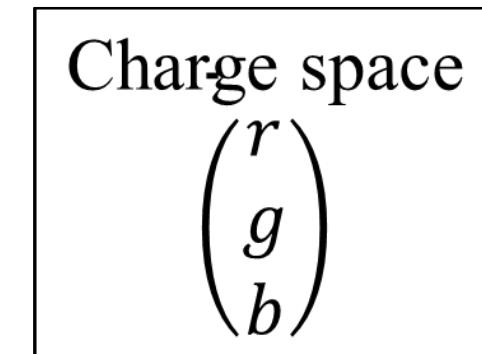
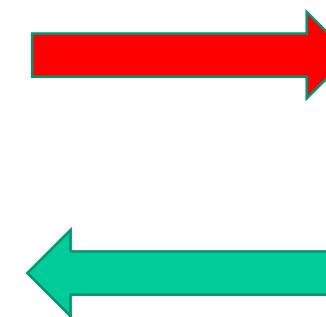
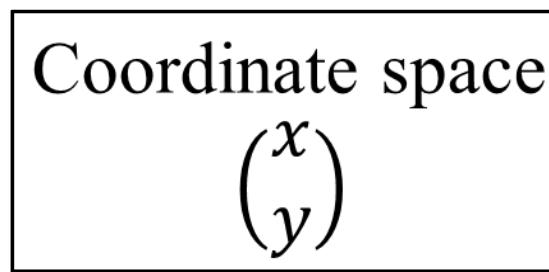


Ternary diagram -> Maxwell triangle

Search for the one-to-one correspondence (bijective function), which correlates
one point identified by
(x, y) within the triangular
region of interest

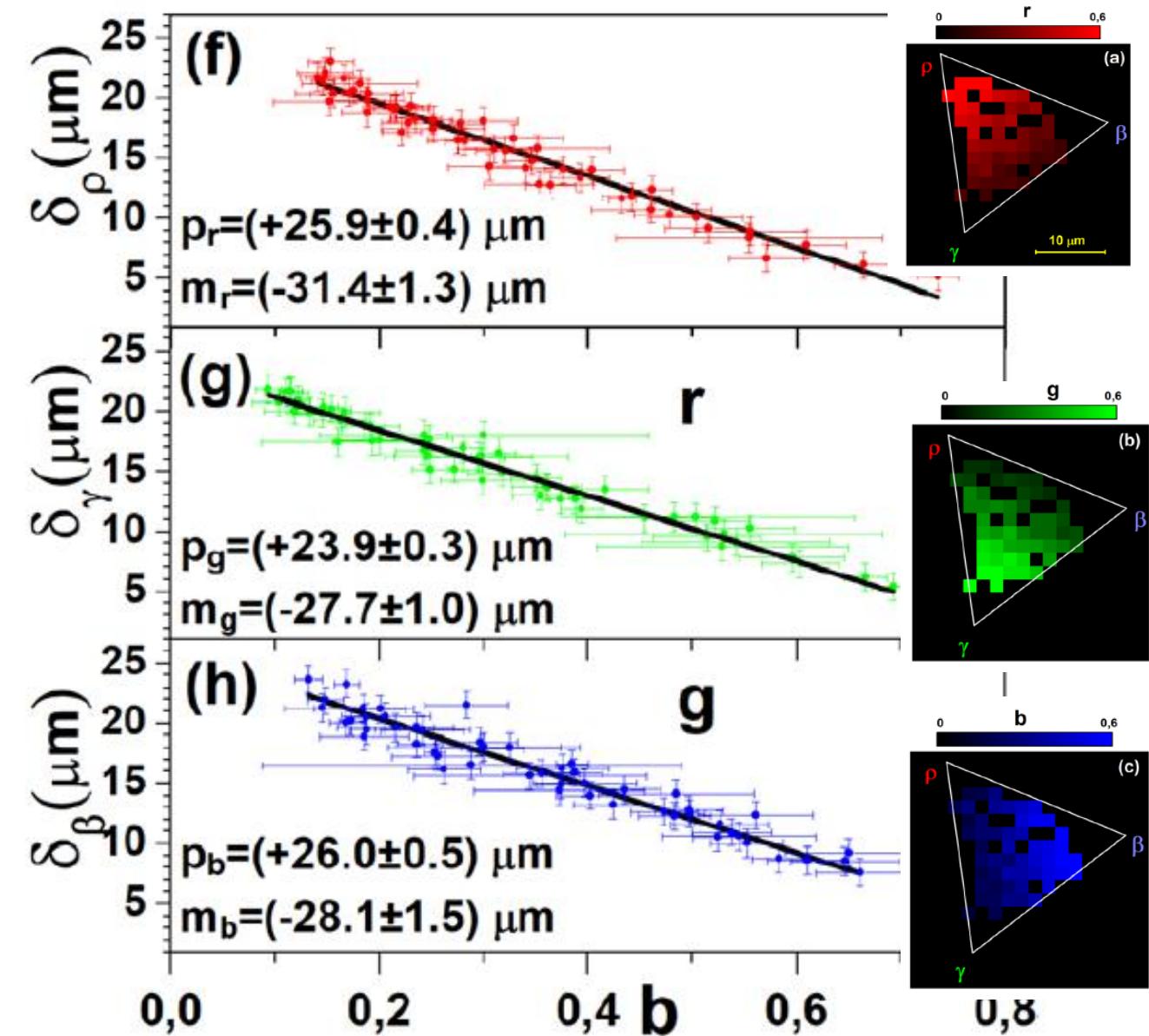
to

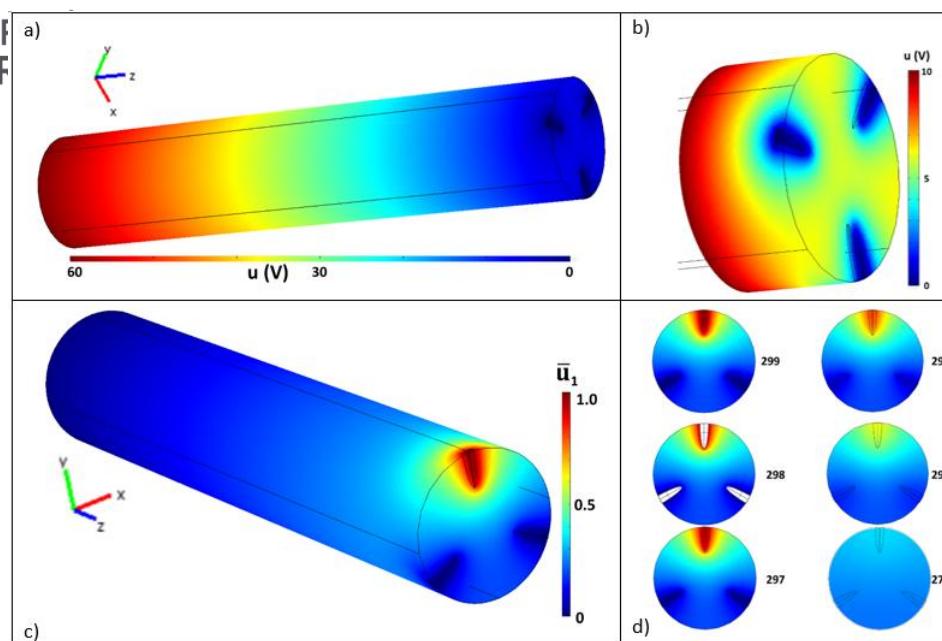
one point identified by
(r, g, b) in the charge space



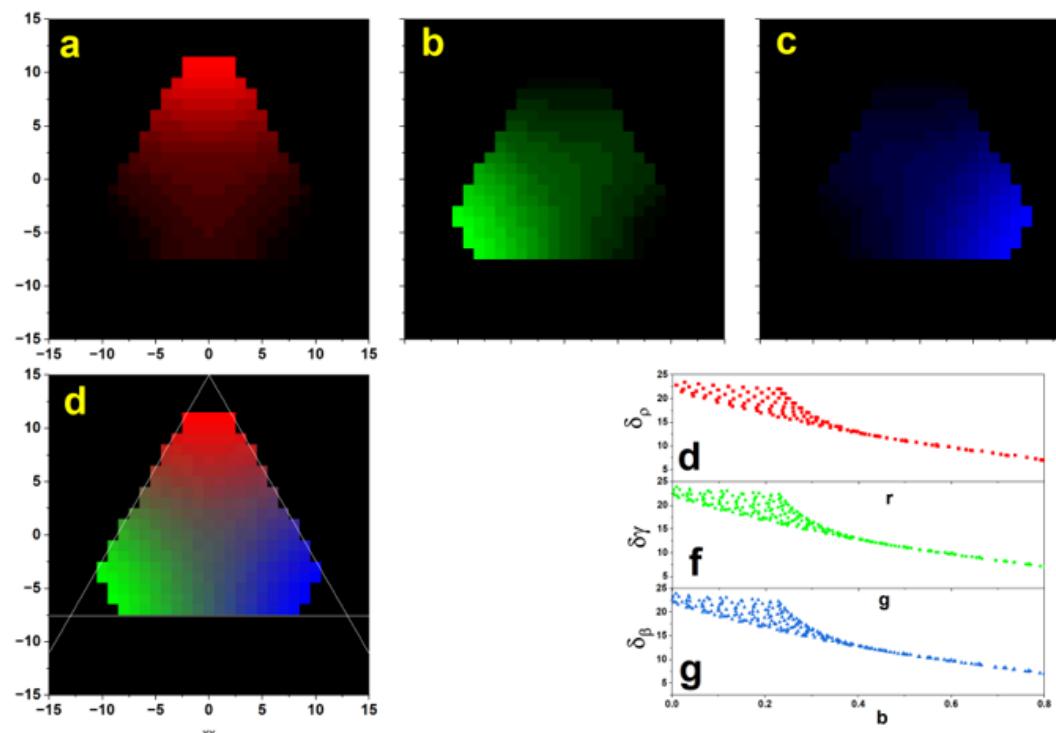
$\delta_{\rho\gamma\beta}$ = distance from the vertex

$$\left\{ \begin{array}{l} \delta_\rho = p_r + m_r \cdot r, \\ \delta_\gamma = p_g + m_g \cdot g, \\ \delta_\beta = p_b + m_b \cdot b, \end{array} \right.$$





Electrostatic potential



Simulated r,g,b maps

Coordinate space

$$\begin{pmatrix} x \\ y \end{pmatrix}$$



Charge space

$$\begin{pmatrix} r \\ g \\ b \end{pmatrix}$$



$$\left\{ \begin{array}{l} \delta_\rho = p_r + m_r \cdot r, \\ \delta_\gamma = p_g + m_g \cdot g, \\ \delta_\beta = p_b + m_b \cdot b, \end{array} \right.$$

Coordinates of the vertex

$$\rho \Rightarrow (x_\rho, y_\rho)$$

$$\gamma \Rightarrow (x_\gamma, y_\gamma)$$

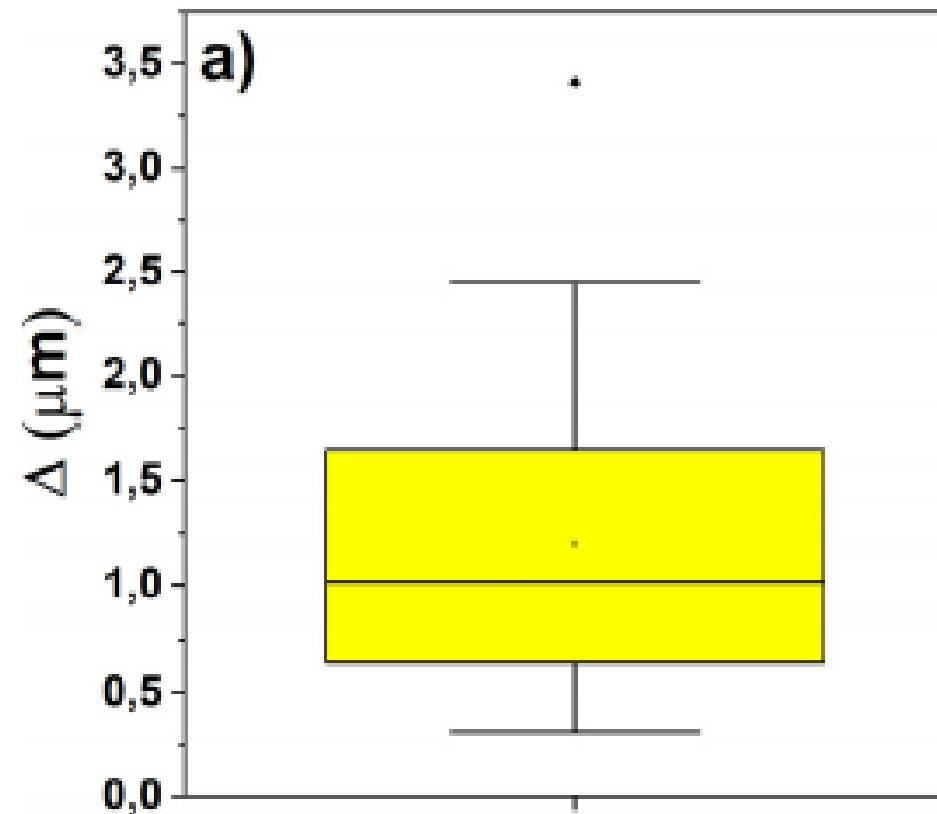
$$\beta \Rightarrow (x_\beta, y_\beta)$$

$$x_{pred} = + \frac{1}{2} \frac{y_\beta (\delta_\rho^2 - x_\rho^2 - y_\rho^2 - \delta_\gamma^2 + x_\gamma^2 + y_\gamma^2) + y_\gamma (\delta_\beta^2 - x_\beta^2 - y_\beta^2 - \delta_\rho^2 + x_\rho^2 + y_\rho^2) + y_\rho (\delta_\gamma^2 - x_\gamma^2 - y_\gamma^2 - \delta_\beta^2 + x_\beta^2 + y_\beta^2)}{(y_\beta - y_\rho)(x_\gamma - x_\rho) - (x_\beta - x_\rho)(y_\gamma - y_\rho)},$$

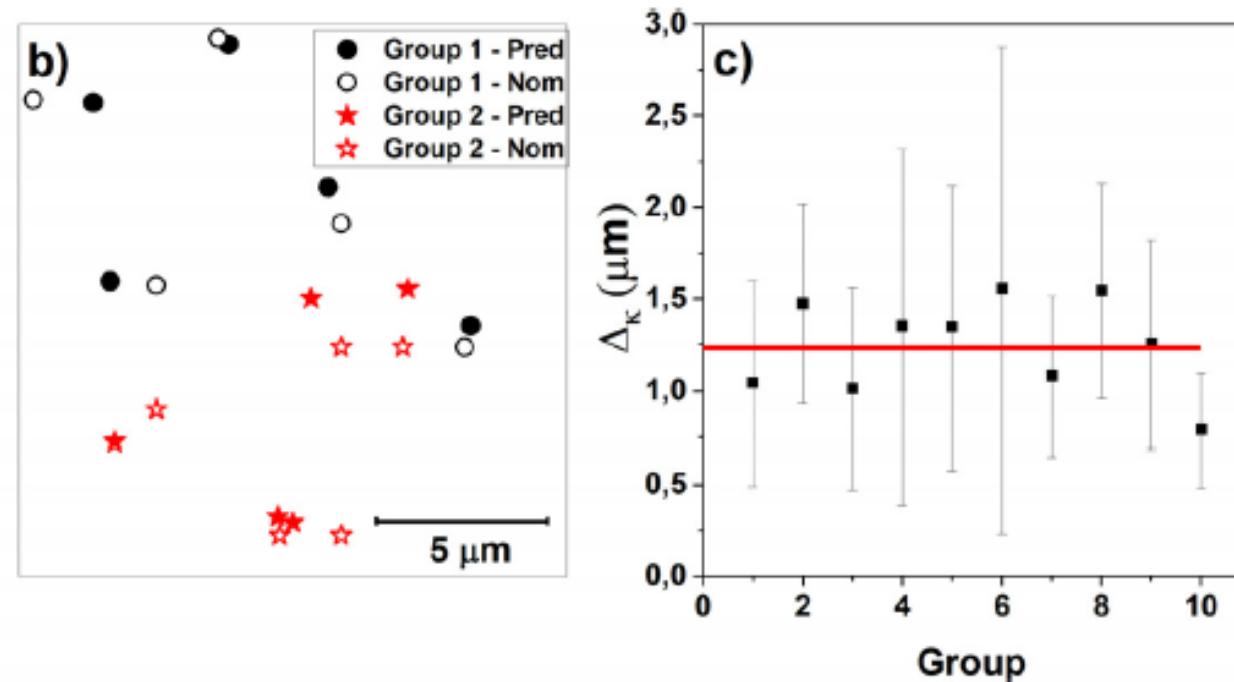
$$y_{pred} = - \frac{1}{2} \frac{x_\beta (\delta_\rho^2 - x_\rho^2 - y_\rho^2 - \delta_\gamma^2 + x_\gamma^2 + y_\gamma^2) + x_\gamma (\delta_\beta^2 - x_\beta^2 - y_\beta^2 - \delta_\rho^2 + x_\rho^2 + y_\rho^2) + x_\rho (\delta_\gamma^2 - x_\gamma^2 - y_\gamma^2 - \delta_\beta^2 + x_\beta^2 + y_\beta^2)}{(y_\beta - y_\rho)(x_\gamma - x_\rho) - (x_\beta - x_\rho)(y_\gamma - y_\rho)}.$$

Boxplot of the distribution distances D_i of the nominal impact point position from the predicted impact point,

$$\Delta_i = \sqrt{(x_{pred,i} - x_{nom,i})^2 + (y_{pred,i} - y_{nom,i})^2}.$$



Predictive accuracy of the model through the tenfold cross validation test.



The 52 data points were randomly assigned to ten groups, containing five points identified by the three “charge” coordinates (r , g , b) relevant to the nominal point of coordinates (x_{nom} , y_{nom}).

In turns, the remaining 47 points were used to build the above described model to evaluate the predicted impact point (x_{pred} , y_{pred}).

In this 2nd lecture

- The Gunn's theorem provides the theoretical background to compute the induced charge signal in multielectrode devices
- The formalism correlates the charge generation position with the charge signals induced in the sensing electrodes
- Bi- or Tri-lateration approaches to retrieve the two-dimensional position of impact of each ion
- The spatial resolution depends on the extension of the active area and on the electronic noise

Limitations

Intrinsic: straggling

Instrumental: Electronics: spectral resolution

1D position sensitive detector

Extension of the active region; 2.5 mm

Ion Probe: 2 MeV H; Spectral resolution: 34 keV

Spatial resolution: 49 µm

E.Vittone et al., "IBIC analysis of a linear position sensitive detector: model and experiment",

Eur. Phys. J. Plus (2025) 140:369

1D position sensitive detector

Extension of the active region; 12 µm

Ion Probe: 2 MeV He; Spectral resolution: 200 keV

Spatial resolution: 0.4 µm

J. Forneris et al., "Modeling of ion beam induced charge sharing experiments for the design of high resolution position sensitive detectors" Nuclear Instruments and Methods in Physics Research B 306 (2013) 169Å–175.

2D position sensitive detector

Extension of the triangular active region: 26 µm side

Ion Probe: 2 MeV Li; Spectral resolution: 20 keV

Spatial resolution: 3 µm

S. Ditalia Tchernj et al. , A multi-electrode two-dimensional position-sensitive diamond detector

Appl. Phys. Lett. 124, 223502 (2024);